

LinkSmart

L43L16064
64MEGABIT (4×1M×16 BIT)
3.3 VOLT CMOS SDRAM MEMERY

PRELIMINARY

A

Revision history

Rev. No.	Approved date	History	Remark (purpose)
A	September 2 2002	Initial issue	Preliminary

■ **DESCRIPTION**

The LST L43L16064 is a CMOS Synchronous Dynamic Random Access Memory (SDRAM) containing 67,108,864 memory cells accessible in a 16-bit format. The L43L16064 features a fully synchronous operation referenced to a positive edge clock whereby all operations are synchronized at a clock input which enables high performance and simple user interface coexistence. The L43L16064 SDRAM is designed to reduce the complexity of using a standard dynamic RAM (DRAM) which requires many control signal timing constraints, and may improve data bandwidth of memory as much as 5 times more than a conventional DRAM.

The L43L16064 is ideally suited for workstations, personal computers, laser printers, high resolution graphic adapters/accelerators and other applications where an extremely large memory and bandwidth are required and where a simple interface is needed.

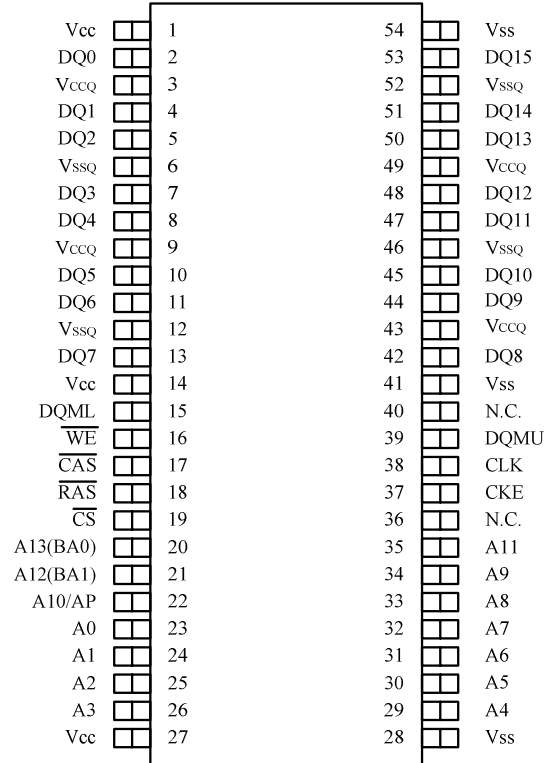
■ **PRODUCT LINE & FEATURES**

Parameter	L43L16064	
	-75	Reference Value @66MHz(CL=2)
CL - t _{RCD} - t _{RP}	3 - 3 - 3 clk min.	2 - 2 - 2 clk min.
Clock Frequency	133 MHz max.	66 MHz max.
Burst Mode Cycle Time	CL=2	10 ns min.
	CL=3	7.5 ns min.
Access Time From Clock	CL=2	6 ns max.
	CL=3	6 ns max.
Operating Current	90 mA max.	70 mA max.
Power Down Mode Current (I _{CC2P})	1 mA max.	1 mA max.
Self Refresh Current (I _{CC6})	1 mA max.	1 mA max.

- Single +3.3 V Supply ±0.3 V tolerance
- LVTTTL compatible I/O interface
- 4 K refresh cycles every 64 ms
- Four bank operation
- Burst read/write operation and burst read/single write operation capability
- Programmable burst type, burst length, and CAS latency
- Auto-and Self-refresh (every 15.6 μs)
- CKE power down mode
- Output Enable and Input Data Mask

■ PIN ASSIGNMENTS AND DESCRIPTIONS

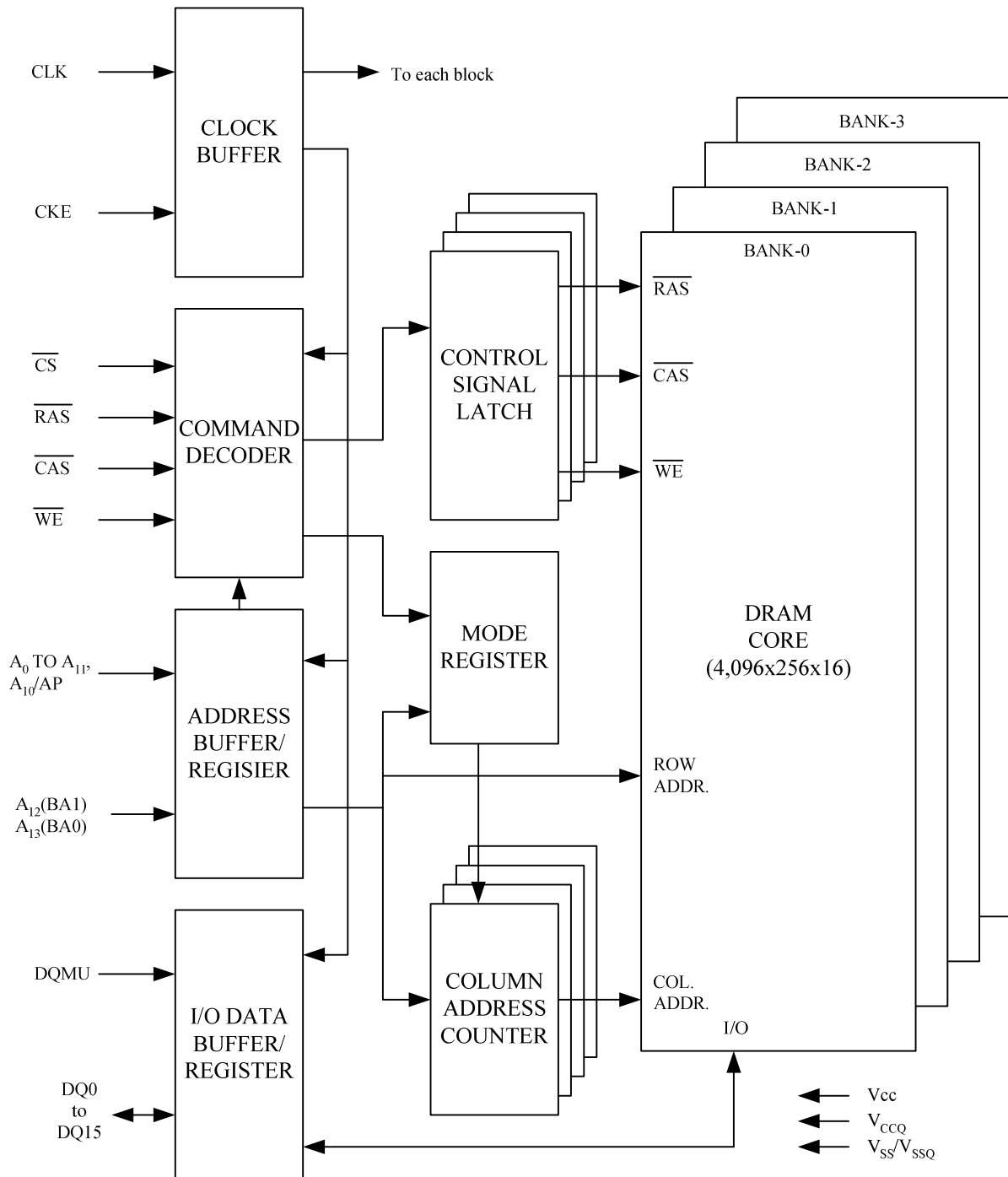
54-Pin TSOP(II) (TOP VIEW)



Pin Number	Symbol	Function
1, 3, 9, 14, 27, 43, 49	V _{CC} , V _{CCQ}	Supply Voltage
2, 4, 5, 7, 8, 10, 11, 13, 42, 44, 45, 47, 48, 50, 51, 53	DQ0 to DQ15	Data I/O •Lower Byte : DQ0 to DQ7 •Upper Byte : DQ8 to DQ15
6, 12, 28, 41, 46, 52, 54	V _{SS} , V _{SSQ} *	Ground
36, 40	N.C.	No Connection
16	WE	Write Enable
17	CAS	Column Address Strobe
18	RAS	Row Address Strobe
19	CS	Chip Select
20,21	A13 (BA0), A12 (BA1)	Bank Select (Bank Address)
22	AP	Auto Precharge Enable
22, 23, 24, 25, 26, 29, 30, 31, 32, 33, 34, 35	A0-A11	Address Input •Row: A0 to A11 •Column: A0 to A7
37	CKE	Clock Enable
38	CLK	Clock Input
15,39	DQML, DQMU	DQ MASK

* :These pins are connected internally in the chip.

■ **BLOCK DIAGRAM**



■ **FUNCTIONAL TRUTH TABLE Note *1**

COMMAND TRUTH TABLE Note *2, *3, and *4

Function	Notes	Symbol	CKE		$\overline{\text{CS}}$	$\overline{\text{RAS}}$	$\overline{\text{CAS}}$	$\overline{\text{WE}}$	A ₁₃ , A ₁₂ (BA)	A ₁₁	A ₁₀ (AP)	A ₉	A ₈ to A ₀
			n-1	n									
Device Deselect	*5	DESL	H	X	H	X	X	X	X	X	X	X	X
No Operation	*5	NOP	H	X	L	H	H	H	X	X	X	X	X
Burst Stop		BST	H	X	L	H	H	L	X	X	X	X	X
Read	*6	READ	H	X	L	H	L	H	V	X	L	X	V
Read with Auto-precharge	*6	READA	H	X	L	H	L	H	V	X	H	X	V
Write	*6	WRIT	H	X	L	H	L	L	V	X	L	X	V
Write with Auto-precharge	*6	WRITA	H	X	L	H	L	L	V	X	H	X	V
Bank Active	*7	ACTV	H	X	L	L	H	H	V	V	V	V	V
Precharge Single Bank		PRE	H	X	L	L	H	L	V	X	L	X	X
Precharge All Banks		PALL	H	X	L	L	H	L	X	X	H	X	X
Mode Register Set	*8,9	MRS	H	X	L	L	L	L	L	L	L	V	V

Notes: *1. V = Valid, L = Logic Low, H = Logic High, X = either L or H.

*2. All commands assume no CSUS command on previous rising edge of clock.

*3. All commands are assumed to be valid state transitions.

*4. All inputs are latched on the rising edge of clock.

*5. NOP and DESL commands have the same effect on the part. Unless specifically noted, NOP will represent both NOP and DESL command in later descriptions.

*6. READ, READA, WRIT and WRITA commands should only be issued after the corresponding bank has been activated (ACTV command). Refer to STATE DIAGRAM.

*7. ACTV command should only be issued after corresponding bank has been precharged (PRE or PALL command).

*8. Required after power up. Refer to POWER-UP INITIALIZATION in page 19.

*9. MRS command should only be issued after all banks have been precharged (PRE or PALL command). Refer to STATE DIAGRAM.

DQM TRUTH TABLE

Function	Symbol	CKE		DQML	DQMU
		n-1	n		
Data Write/Output Enable for Lower Byte	ENBL L	H	X	L	X
Data Write/Output Enable for Upper Byte	ENBL U	H	X	X	L
Data Mask/Output Disable for Lower Byte	MASK L	H	X	H	X
Data Mask/Output Disable for Upper Byte	MASK U	H	X	X	H

CKE TRUTH TABLE

Current State	Function	Notes	Symbol	CKE		$\overline{\text{CS}}$	$\overline{\text{RAS}}$	$\overline{\text{CAS}}$	$\overline{\text{WE}}$	A ₁₃ , A ₁₂ (BA)	A ₁₁	A ₁₀ (AP)	A ₉ to A ₀
				n-1	n								
Bank Active	Clock Suspend Mode Entry	*1	CSUS	H	L	X	X	X	X	X	X	X	X
Any (Except Idle)	Clock Suspend Continue	*1		L	L	X	X	X	X	X	X	X	X
Clock Suspend	Clock Suspend Mode Exit			L	H	X	X	X	X	X	X	X	X
Idle	Auto-refresh Command	*2	REF	H	H	L	L	L	H	X	X	X	X
Idle	Self-refresh Entry	*2,3	SELF	H	L	L	L	L	H	X	X	X	X
Self Refresh	Self-refresh Exit		SELF	L	H	L	H	H	H	X	X	X	X
				L	H	H	X	X	X	X	X	X	X
Idle	Power Down Entry	*3	PD	H	L	L	H	H	H	X	X	X	X
				H	L	H	X	X	X	X	X	X	X
Power Down	Power Down Exit			L	H	L	H	H	H	X	X	X	X
				L	H	H	X	X	X	X	X	X	X

Notes: *1. The CSUS command requires that at least one bank is active. Refer to STATE DIAGRAM.

NOP or DESL command should be issued after CSUS and PRE (or PALL) commands asserted at the same time.

*2. REF and SELF commands should only be issued after all banks have been precharged (PRE or PALL command). Refer to STATE DIAGRAM.

*3. SELF and PD commands should only be issued after the last read data have been appeared on DQ.

OPERATION COMMAND TABLE (Applicable to single bank) Note *1

Current State	$\overline{\text{CS}}$	$\overline{\text{RAS}}$	$\overline{\text{CAS}}$	$\overline{\text{WE}}$	Addr.	Command	Function	Notes
Idle	H	X	X	X	X	DESL	NOP	
	L	H	H	H	X	NOP	NOP	
	L	H	H	L	X	BST	NOP	
	L	H	L	H	BA, CA, AP	READ/READA	Illegal	*2
	L	H	L	L	BA, CA, AP	WRIT/WRITA	Illegal	*2
	L	L	H	H	BA, RA	ACTV	Bank Active after t_{RCD}	
	L	L	H	L	BA, AP	PRE/PALL	NOP	
	L	L	L	H	X	REF/SELF	Auto-refresh or Self-refresh	*3,6
	L	L	L	L	MODE	MRS	Mode Register Set (Idle after t_{RSC})	*3,7
Bank Active	H	X	X	X	X	DESL	NOP	
	L	H	H	H	X	NOP	NOP	
	L	H	H	L	X	BST	NOP	
	L	H	L	H	BA, CA, AP	READ/READA	Begin Read; Determine AP	
	L	H	L	L	BA, CA, AP	WRIT/WRITA	Begin Write; Determine AP	
	L	L	H	H	BA, RA	ACTV	Illegal	*2
	L	L	H	L	BA, AP	PRE/PALL	Precharge; Determine Precharge Type	
	L	L	L	H	X	REF/SELF	Illegal	
	L	L	L	L	MODE	MRS	Illegal	

(Continued)

Current State	\overline{CS}	\overline{RAS}	\overline{CAS}	\overline{WE}	Addr.	Command	Function	Notes
Read	H	X	X	X	X	DESL	NOP (Continue Burst to End → Bank Active)	
	L	H	H	H	X	NOP	NOP (Continue Burst to End → Bank Active)	
	L	H	H	L	X	BST	Burst Stop → Bank Active	
	L	H	L	H	BA, CA, AP	READ/READA	Terminate Burst, New Read; Determine AP	
	L	H	L	L	BA, CA, AP	WRIT/WRITA	Terminate Burst, Start Write; Determine AP	*4
	L	L	H	H	BA, RA	ACTV	Illegal	*2
	L	L	H	L	BA, AP	PRE/PALL	Terminate Burst, Precharge → Idle; Determine Precharge Type	
	L	L	L	H	X	REF/SELF	Illegal	
	L	L	L	L	MODE	MRS	Illegal	
Write	H	X	X	X	X	DESL	NOP (Continue Burst to End → Bank Active)	
	L	H	H	H	X	NOP	NOP (Continue Burst to End → Bank Active)	
	L	H	H	L	X	BST	Burst Stop → Bank Active	
	L	H	L	H	BA, CA, AP	READ/READA	Terminate Burst, New Read; Determine AP	
	L	H	L	L	BA, CA, AP	WRIT/WRITA	Terminate Burst, Start Write; Determine AP	*4
	L	L	H	H	BA, RA	ACTV	Illegal	*2
	L	L	H	L	BA, AP	PRE/PALL	Terminate Burst, Precharge → Idle; Determine Precharge Type	
	L	L	L	H	X	REF/SELF	Illegal	
	L	L	L	L	MODE	MRS	Illegal	

(Continued)

Current State	\overline{CS}	\overline{RAS}	\overline{CAS}	\overline{WE}	Addr.	Command	Function	Notes
Read with Auto-precharge	H	X	X	X	X	DESL	NOP (Continue Burst to End → Precharge → Idle)	
	L	H	H	H	X	NOP	NOP (Continue Burst to End → Precharge → Idle)	
	L	H	H	L	X	BST	Illegal	
	L	H	L	H	BA, CA, AP	READ/READA	Illegal	*2
	L	H	L	L	BA, CA, AP	WRIT/WRITA	Illegal	*2
	L	L	H	H	BA, RA	ACTV	Illegal	*2
	L	L	H	L	BA, AP	PRE/PALL	Illegal	*2
	L	L	L	H	X	REF/SELF	Illegal	
	L	L	L	L	MODE	MRS	Illegal	
Write with Auto-precharge	H	X	X	X	X	DESL	NOP (Continue Burst to End → Precharge → Idle)	
	L	H	H	H	X	NOP	NOP (Continue Burst to End → Precharge → Idle)	
	L	H	H	L	X	BST	Illegal	
	L	H	L	H	BA, CA, AP	READ/READA	Illegal	*2
	L	H	L	L	BA, CA, AP	WRIT/WRITA	Illegal	*2
	L	L	H	H	BA, RA	ACTV	Illegal	*2
	L	L	H	L	BA, AP	PRE/PALL	Illegal	*2
	L	L	L	H	X	REF/SELF	Illegal	
	L	L	L	L	MODE	MRS	Illegal	

(Continued)

Current State	\overline{CS}	\overline{RAS}	\overline{CAS}	\overline{WE}	Addr.	Command	Function	Notes
Precharging	H	X	X	X	X	DESL	NOP (Idle after t_{RP})	
	L	H	H	H	X	NOP	NOP (Idle after t_{RP})	
	L	H	H	L	X	BST	NOP (Idle after t_{RP})	
	L	H	L	H	BA, CA, AP	READ/READA	Illegal	*2
	L	H	L	L	BA, CA, AP	WRIT/WRITA	Illegal	*2
	L	L	H	H	BA, RA	ACTV	Illegal	*2
	L	L	H	L	BA, AP	PRE/PALL	NOP (PALL may affect other bank) *5	
	L	L	L	H	X	REF/SELF	Illegal	
	L	L	L	L	MODE	MRS	Illegal	
Bank Activating	H	X	X	X	X	DESL	NOP (Bank Active after t_{RCD})	
	L	H	H	H	X	NOP	NOP (Bank Active after t_{RCD})	
	L	H	H	L	X	BST	NOP (Bank Active after t_{RCD})	
	L	H	L	H	BA, CA, AP	READ/READA	Illegal	*2
	L	H	L	L	BA, CA, AP	WRIT/WRITA	Illegal	*2
	L	L	H	H	BA, RA	ACTV	Illegal	*2
	L	L	H	L	BA, AP	PRE/PALL	Illegal	*2
	L	L	L	H	X	REF/SELF	Illegal	
	L	L	L	L	MODE	MRS	Illegal	

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Current State	\overline{CS}	\overline{RAS}	\overline{CAS}	\overline{WE}	Addr.	Command	Function	Notes
Refreshing	H	X	X	X	X	DESL	NOP (Idle after t_{RC})	
	L	H	H	X	X	NOP/BST	NOP (Idle after t_{RC})	
	L	H	L	X	X	READ/READA/ WRIT/WRITA	Illegal	
	L	L	H	X	X	ACTV/ PRE/PALL	Illegal	
	L	L	L	X	X	REF/SELF/ MRS Illegal	Illegal	
Mode Register Setting	H	X	X	X	X	DESL	NOP (Idle after t_{RSC})	
	L	H	H	H	X	NOP	NOP (Idle after t_{RSC})	
	L	H	H	L	X	BST	Illegal	
	L	H	L	X	X	READ/READA/ WRIT/WRITA	Illegal	
	L	L	X	X	X	ACTV/PRE/ PALL/REF/ SELF/MRS	Illegal	

ABBREVIATIONS:

RA = Row Address

BA = Bank Address

CA = Column Address

AP = Auto Precharge

Notes: *1. All entries in OPERATION COMMAND TABLE assume the CKE was High during the proceeding clock cycle and the current clock cycle.

Illegal means don't used command. If used, power up sequence be asserted after power shut down.

*2. Illegal to bank in specified state; entry may be legal in the bank specified by BA, depending on the state of that bank.

*3. Illegal if any bank is not idle.

*4. Must satisfy bus contention, bus turn around, and/or write recovery requirements.

Refer to TIMING DIAGRAM -11 & -12.

*5. NOP to bank precharging or in idle state. May precharge bank specified by BA (and AP).

*6. SELF command should only be issued after the last read data have been appeared on DQ.

*7. MRS command should only be issued on condition that all DQ are in Hi-Z.

COMMAND TRUTH TABLE FOR CKE Note *1

Current State	CKE n-1	CKE n	\overline{CS}	\overline{RAS}	\overline{CAS}	\overline{WE}	Addr.	Function	Notes
Self-refresh	H	X	X	X	X	X	X	Invalid	
	L	H	H	X	X	X	X	Exit Self-refresh (Self-refresh Recovery → Idle after t _{RC})	
	L	H	L	H	H	H	X	Exit Self-refresh (Self-refresh Recovery → Idle after t _{RC})	
	L	H	L	H	H	L	X	Illegal	
	L	H	L	H	L	X	X	Illegal	
	L	H	L	L	X	X	X	Illegal	
	L	L	X	X	X	X	X	NOP (Maintain Self-refresh)	
Self-refresh Recovery	L	X	X	X	X	X	X	Invalid	
	H	H	H	X	X	X	X	Idle after t _{RC}	
	H	H	L	X	H	H	X	Idle after t _{RC}	
	H	H	L	H	H	L	X	Illegal	
	H	H	L	H	L	X	X	Illegal	
	H	H	L	L	X	X	X	Illegal	
	H	L	X	X	X	X	X	Illegal	*2

(Continued)

Current State	CKE n-1	CKE n	\overline{CS}	\overline{RAS}	\overline{CAS}	\overline{WE}	Addr.	Function	Notes
Power Down	H	X	X	X	X	X	X	Invalid	
	L	H	H	X	X	X	X	Exit Power Down Mode → Idle	
	L	H	L	H	H	H	X		
	L	L	X	X	X	X	X	NOP (Maintain Power Down Mode)	
	L	H	L	L	X	X	X	Illegal	
	L	H	L	H	L	X	X	Illegal	
	L	H	L	H	H	X	X	Illegal	
All Banks Idle	H	H	H	X	X	X	MODE	Refer to the Operation Command Table.	
	H	H	L	H	X	X	MODE	Refer to the Operation Command Table.	
	H	H	L	L	H	X	MODE	Refer to the Operation Command Table.	
	H	H	L	L	L	H	X	Auto-refresh	
	H	H	L	L	L	L	MODE	Refer to the Operation Command Table	
	H	L	H	X	X	X	X	Power Down	
	H	L	L	H	H	H	X	Power Down	
	H	L	L	H	H	L	X	Illegal	
	H	L	L	H	L	X	X	Illegal	
	H	L	L	L	H	X	X	Illegal	
	H	L	L	L	L	H	X	Self-refresh	*3
	H	L	L	L	L	L	X	Illegal	
	L	X	X	X	X	X	X	Invalid	

(Continued)

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Current State	CKE n-1	CKE n	\overline{CS}	\overline{RAS}	\overline{CAS}	\overline{WE}	Addr.	Function	Notes
Bank Active Bank Activating Read/Write	H	H	X	X	X	X	X	Refer to the Operation Command Table.	
Read with Auto- precharge/ Write with Auto- precharge	H	L	X	X	X	X	X	Begin Clock Suspend next cycle	
	L	X	X	X	X	X	X	Invalid	
Clock Suspend	H	X	X	X	X	X	X	Invalid	
	L	H	X	X	X	X	X	Exit Clock Suspend next cycle	
	L	L	X	X	X	X	X	Maintain Clock Suspend	
Any State Other Than Listed Above	L	X	X	X	X	X	X	Invalid	
	H	H	X	X	X	X	X	Refer to the Operation Command Table.	
	H	L	X	X	X	X	X	Illegal	

- Notes:** *1. All entries in COMMAND TRUTH TABLE FOR CKE are specified at CKE (n) state and CKE input from CKE (n-1) to CKE (n) state must satisfy corresponding set up and hold time for CKE.
*2. CKE should be held High for t_{RC} period.
*3. SELF command should only be issued after the last data have been appeared on DQ.

■ FUNCTIONAL DESCRIPTION

SDRAM BASIC FUNCTION

Three major differences between this SDRAM and conventional DRAMs are: synchronized operation, burst mode, and mode register.

The **synchronized operation** is the fundamental difference. An SDRAM uses a clock input for the synchronization, where the DRAM is basically asynchronous memory although it has been using two clocks, \overline{RAS} and \overline{CAS} . Each operation of DRAM is determined by their timing phase differences while each operation of SDRAM is determined by commands and all operations are referenced to a positive clock edge. Fig 2 shows the basic timing diagram differences between SDRAMs and DRAMs.

The **burst mode** is a very high speed access mode utilizing an internal column address generator. Once a column addresses for the first access is set, following addresses are automatically generated by the internal column address counter.

The **mode register** is to justify the SDRAM operation and function into desired system conditions. MODE REGISTER TABLE shows how SDRAM can be configured for system requirement by mode register programming.

CLOCK (CLK) and CLOCK ENABLE (CKE)

All input and output signals of SDRAM use register type buffers. A CLK is used as a trigger for the register and internal burst counter increment. All inputs are latched by a positive edge of CLK. All outputs are validated by the CLK. CKE is a high active clock enable signal. When CKE = Low is latched at a clock input during active cycle, the next clock will be internally masked. During idle state (all banks have been precharged), the Power Down mode (standby) is entered with CKE = Low and this will make extremely low standby current.

CHIP SELECT (\overline{CS})

\overline{CS} enables all commands inputs, \overline{RAS} , \overline{CAS} , and \overline{CS} , and address input. When \overline{CS} is High, command signals are negated but internal operation such as burst cycle will not be suspended. If such a control isn't needed, \overline{CS} can be tied to ground level.

COMMAND INPUT (\overline{RAS} , \overline{CAS} and \overline{WE})

Unlike a conventional DRAM, \overline{RAS} , \overline{CAS} , and \overline{WE} do not directly imply SDRAM operation, such as Row address strobe by \overline{RAS} . Instead, each combination of \overline{RAS} , \overline{CAS} , and \overline{WE} input in conjunction with \overline{CS} input at a rising edge of the CLK determines SDRAM operation. Refer to FUNCTIONAL TRUTH TABLE in page 5.

ADDRESS INPUT (A0 to A11)

Address input selects an arbitrary location of a total of 1,048,576 words of each memory cell matrix. A total of twenty address input signals are required to decode such a matrix. SDRAM adopts an address multiplexer in order to reduce the pin count of the address line. At a Bank Active command (ACTV), twelve Row addresses are initially latched and the remainder of eight Column addresses are then latched by a Column address strobe command of either a Read command (READ or READA) or Write command (WRIT or WRITA).

BANK SELECT (A12, A13)

This SDRAM has four banks and each bank is organized as 1 M words by 16-bit.

Bank selection by A₁₃, A₁₂ occurs at Bank Active command (ACTV) followed by read (READ or READA), write (WRIT or WRITA), and precharge command (PRE).

DATA INPUTS AND OUTPUTS (DQ0 to DQ15)

Input data is latched and written into the memory at the clock following the write command input. Data output is obtained by the following conditions followed by a read command input:

t_{RAC} ; from the bank active command when t_{RCD} (min) is satisfied. (This parameter is reference only.)

t_{CAC} ; from the read command when t_{RCD} is greater than t_{RCD} (min). (This parameter is reference only.)

t_{AC} ; from the clock edge after t_{RAC} and t_{CAC} .

The polarity of the output data is identical to that of the input. Data is valid between access time (determined by the three conditions above) and the next positive clock edge (t_{OH}).

DATA I/O MASK (DQML/DQMU)

DQML and DQMU are an active high enable input and has an output disable and input mask function. During burst cycle and when DQML/DQMU = High is latched by a clock, input is masked at the same clock and output will be masked at the second clock later while internal burst counter will increment by one or will go to the next stage depending on burst type.

BURST MODE OPERATION AND BURST TYPE

The burst mode provides faster memory access. The burst mode is implemented by keeping the same Row address and by automatic strobing column address. Access time and cycle time of Burst mode is specified as t_{AC} and t_{CK} , respectively. The internal column address counter operation is determined by a mode register which defines burst type and burst count length of 1, 2, 4 or 8 bits of boundary. In order to terminate or to move from the current burst mode to the next stage while the remaining burst count is more than 1, the following combinations will be required:

Current Stage	Next Stage	Method (Assert the following command)	
Burst Read	Burst Read	Read Command	
Burst Read	Burst Write	1st Step	Mask Command (Normally 3 clock cycles)
		2nd Step	Write Command after low_D
Burst Write	Burst Write	Write Command	
Burst Write	Burst Read	Read Command	
Burst Read	Precharge	Precharge Command	
Burst Write	Precharge	Precharge Command	

The burst type can be selected either sequential or interleave mode if burst length is 2, 4 or 8. The sequential mode is an incremental decoding scheme within a boundary address to be determined by count length, it assigns +1 to the previous (or initial) address until reaching the end of boundary address and then wraps round to least significant address (= 0). The interleave mode is a scrambled decoding scheme for A0 and A2. If the first access of column address is even (0), the next address will be odd (1), or vice-versa.

When the full burst operation is executed at single write mode, Auto-precharge command is valid only at write operation.

The burst type can be selected either sequential or interleave mode. But only the sequential mode is usable to the full column burst. The sequential mode is an incremental decoding scheme within a boundary address to be determined by burst length, it assigns +1 to the previous (or initial) address until reaching the end of boundary address and then wraps round to least significant address (= 0).

Burst Length	Starting Column Address A ₂ A ₁ A ₀	Sequential Mode	Interleave
2	X X 0	0-1	0-1
	X X 1	1-0	1-0
4	X 0 0	0-1-2-3	0-1-2-3
	X 0 1	1-2-3-0	1-0-3-2
	X 1 0	2-3-0-1	2-3-0-1
	X 1 1	3-0-1-2	3-2-1-0
8	0 0 0	0-1-2-3-4-5-6-7	0-1-2-3-4-5-6-7
	0 0 1	1-2-3-4-5-6-7-0	1-0-3-2-5-4-7-6
	0 1 0	2-3-4-5-6-7-0-1	2-3-0-1-6-7-4-5
	0 1 1	3-4-5-6-7-0-1-2	3-2-1-0-7-6-5-4
	1 0 0	4-5-6-7-0-1-2-3	4-5-6-7-0-1-2-3
	1 0 1	5-6-7-0-1-2-3-4	5-4-7-6-1-0-3-2
	1 1 0	6-7-0-1-2-3-4-5	6-7-4-5-2-3-0-1
	1 1 1	7-0-1-2-3-4-5-6	7-6-5-4-3-2-1-0

FULL COLUMN BURST AND BURST STOP COMMAND (BST)

The full column burst is an option of burst length and available only at sequential mode of burst type. This full column burst mode is repeatedly access to the same column. If burst mode reaches end of column address, then it wraps round to first column address (= 0) and continues to count until interrupted by the news read (READ) /write (WRIT), precharge (PRE), or burst stop (BST) command. The selection of Auto-precharge option is illegal during the full column burst operation except write command at BURST READ & SINGLE WRITE mode.

The BST command is applicable to terminate the burst operation. If the BST command is asserted during the burst mode, its operation is terminated immediately and the internal state moves to Bank Active.

When read mode is interrupted by BST command, the output will be in High-Z.

For the detail rule, please refer to TIMING DIAGRAM-8.

When write mode is interrupted by BST command, the data to be applied at the same time with BST command will be ignored.

BURST READ & SINGLE WRITE

The burst read and single write mode provides single word write operation regardless of its burst length. In this mode, burst read operation does not be affected by this mode.

PRECHARGE AND PRECHARGE OPTION (PRE, PALL)

SDRAM memory core is the same as conventional DRAMs', requiring precharge and refresh operations. Precharge rewrites the bit line and to reset the internal Row address line and is executed by the Precharge command (PRE).

With the Precharge command, SDRAM will automatically be in standby state after precharge time (tRP).

The precharged bank is selected by combination of AP and A13, A12 when Precharge command is asserted. If AP = High, all banks are precharged regardless of A13, A12 (PALL). If AP = Low, a bank to be selected by A12, A13 is precharged (PRE).

The auto-precharge enters precharge mode at the end of burst mode of read or write without Precharge command assertion.

This auto precharge is entered by AP = High when a read or write command is asserted. Refer to FUNCTIONAL TRUTH TABLE.

AUTO-REFRESH (REF)

Auto-refresh uses the internal refresh address counter. The SDRAM Auto-refresh command (REF) generates Precharge command internally. All banks of SDRAM should be precharged prior to the Auto-refresh command. The Auto-refresh command should also be asserted every 16 μ s or a total 4096 refresh commands within a 64 ms period.

SELF-REFRESH ENTRY (SELF)

Self-refresh function provides automatic refresh by an internal timer as well as Auto-refresh and will continue the refresh function until cancelled by SELFX.

The Self-refresh is entered by applying an Auto-refresh command in conjunction with CKE = Low (SELF). Once SDRAM enters the self-refresh mode, all inputs except for CKE will be "don't care" (either logic high or low level state) and outputs will be in a High-Z state. During a self-refresh mode, CKE = Low should be maintained. SELF command should only be issued after last read data has been appeared on DQ.

Note: When the burst refresh method is used, a total of 4096 auto-refresh commands within 4 ms must be asserted prior to the self-refresh mode entry.

SELF-REFRESH EXIT (SELFX)

To exit self-refresh mode, apply minimum t_{CKSP} after CKE brought high, and then the No operation command (NOP) or the Deselect command (DESL) should be asserted within one t_{RC} period. CKE should be held High within one t_{RC} period after t_{CKSP}. Refer to Timing Diagram-16 for the detail.

It is recommended to assert an Auto-refresh command just after the t_{RC} period to avoid the violation of refresh period.

Note: When the burst refresh method is used, a total of 4096 auto-refresh commands within 4 ms must be asserted after the self-refresh exit.

MODE REGISTER SET (MRS)

The mode register of SDRAM provides a variety of different operations. The register consists of four operation fields; Burst Length, Burst Type, CAS latency, and Operation Code. Refer to MODE REGISTER TABLE.

The mode register can be programmed by the Mode Register Set command (MRS). Each field is set by the address line. Once a mode register is programmed, the contents of the register will be held until re-programmed by another MRS command (or part loses power). MRS command should only be issued on condition that all DQ is in Hi-Z.

The condition of the mode register is undefined after the power-up stage. It is required to set each field after initialization of SDRAM. Refer to POWER-UP INITIALIZATION below.

POWER-UP INITIALIZATION

The SDRAM internal condition after power-up will be undefined. It is required to follow the following Power On Sequence to execute read or write operation.

1. Apply power and start clock. Attempt to maintain either NOP or DESL command at the input.
2. Maintain stable power, stable clock, and NOP condition for a minimum of 100 μ s.
3. Precharge all banks by Precharge (PRE) or Precharge All command (PALL).
4. Assert minimum of 2 Auto-refresh command (REF).
5. Program the mode register by Mode Register Set command (MRS).

In addition, it is recommended DQM and CKE to track V_{CC} to insure that output is High-Z state. The Mode Register Set command (MRS) can be set before 2 Auto-refresh command (REF).

Fig.2 - BASIC TIMING FOR CONVENTIONAL DRAM VS SYNCHRONOUS DRAM

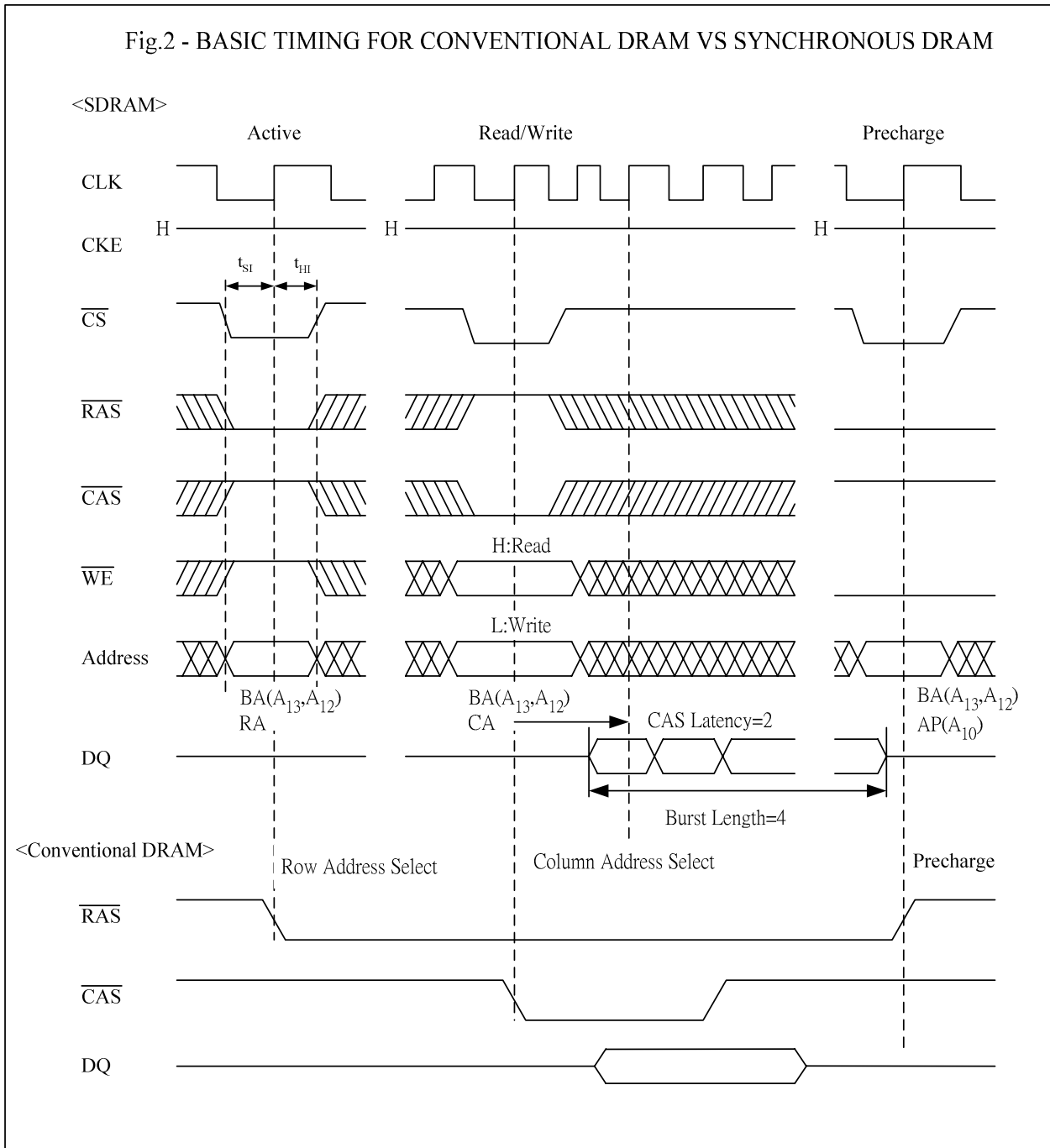
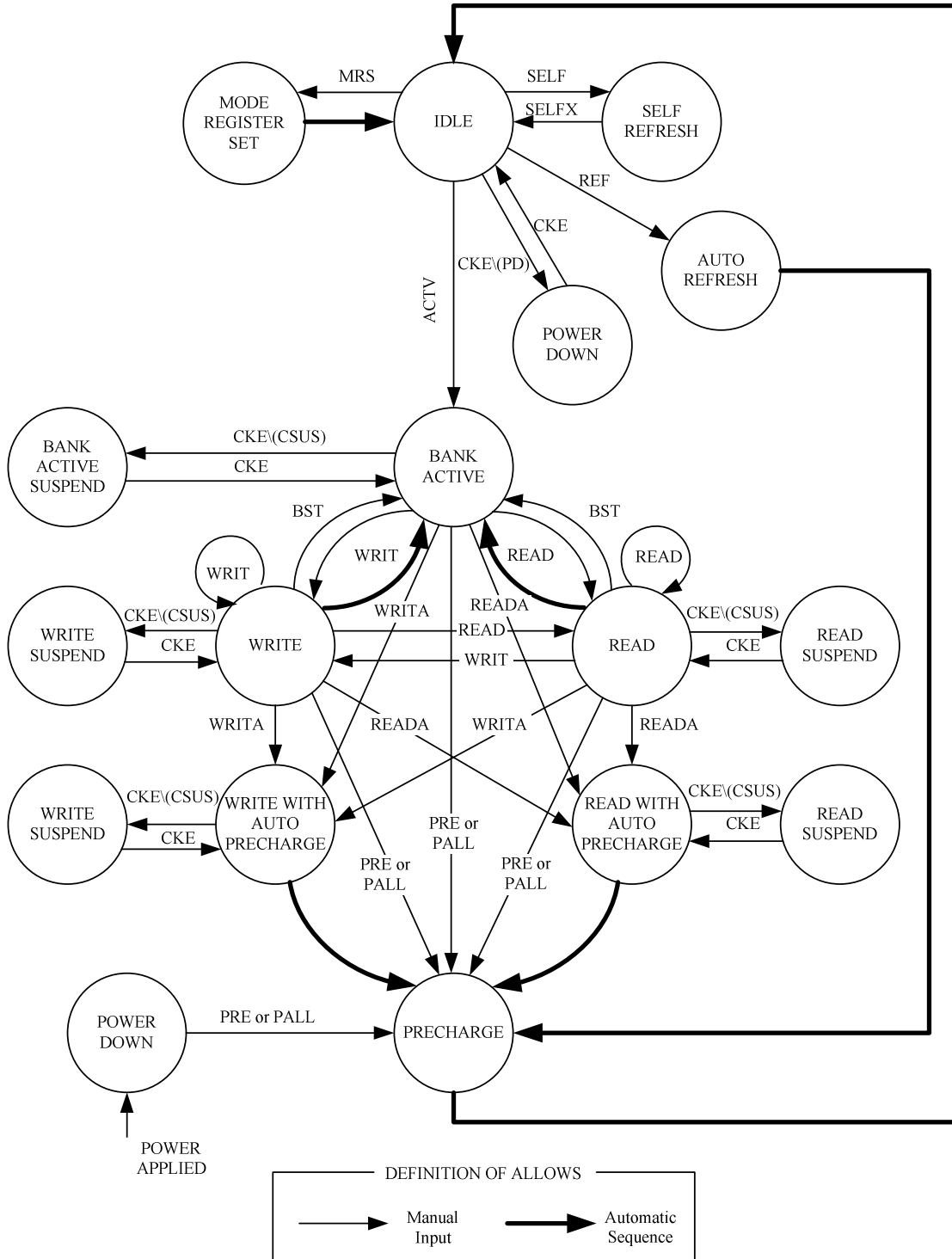


Fig. 3 STATE DIAGRAM (Simplified for BANK Operation State Diagram)



Note: CKE\ means CKE goes Low-level from High-level.

BANK OPERATION COMMAND TABLE

MINIMUM CLOCK LATENCY OR DELAY TIME FOR SINGLE BANK OPERATION

Second Command (same bank) First command	MRS	ACTV	READ	READA ^{*4}	WRIT	WRITA ^{*4}	PRE	PALL	REF	SELF	BST
MRS	t _{RSC}	t _{RSC}					t _{RSC}	t _{RSC}	t _{RSC}	t _{RSC}	t _{RSC}
ACTV			t _{RCD}	t _{RCD}	t _{RCD}	t _{RCD}	t _{RAS}	t _{RAS}			1
READ			1	1	1	1	1	1			1
READA	BL+ ^{*1} t _{RP} ^{*2}	BL+ t _{RP}					BL+ ^{*4} t _{RP}	BL+ ^{*4} t _{RP}	BL+ ^{*2} t _{RP}	BL+ ^{*2} t _{RP} ^{*7}	
WRIT			t _{WR}	t _{WR}	1	1	t _{DPL} ^{*4}	t _{DPL} ^{*4}			1
WRITA	BL-1 ^{*2} + t _{DAL}	BL-1 + t _{DAL}					BL-1 ^{*4} + t _{DAL}	BL-1 ^{*4} + t _{DAL}	BL-1 ^{*2} + t _{DAL}	BL-1 ^{*2} + t _{DAL}	
PRE	t _{RP} ^{*2} ^{*3}	t _{RP}					1	1	t _{RP} ^{*2}	t _{RP} ^{*2} ^{*6}	1
PALL	t _{RP} ^{*3}	t _{RP}					1	1	t _{RP}	t _{RP} ^{*6}	1
REF	t _{RC}	t _{RC}					t _{RC}	t _{RC}	t _{RC}	t _{RC}	t _{RC}
SELFX	t _{RC}	t _{RC}					t _{RC}	t _{RC}	t _{RC}	t _{RC}	t _{RC}

Notes: *1. If t_{RP}(min) ≤ CL × t_{CK}, minimum latency is a sum of (BL + CL) × t_{CK}.

*2. Assume all banks are in Idle state.

*3. Assume output is in High-Z state.

*4. Assume t_{RAS}(min) is satisfied.

*5. Assume no I/O conflict.

*6. Assume after the last data have been appeared on DQ.

*7. If t_{RP}(min) ≤ (CL-1) × t_{CK}, minimum latency is a sum of (BL + CL-1) × t_{CK}.



Illegal Command

■ **MULTI BANK OPERATIVE COMMAND TABLE**

MINIMUM CLOCK LATENCY OR DELAY TIME FOR MULTI BANK OPERATION

Second Command (same bank) First command	MRS	ACTV	READ ^{*5}	READA ^{*5, *6}	WRIT ^{*5}	WRITA ^{*5, *6}	PRE	PALL	REF	SELF	BST
MRS	t_{RSC}	t_{RSC}					t_{RSC}	t_{RSC}	t_{RSC}	t_{RSC}	t_{RSC}
ACTV		^{*2} t_{RRD}	^{*7} 1	^{*7} 1	^{*7} 1	^{*7} 1	^{*6} ^{*7} 1	^{*7} t_{RAS}			1
READ		^{*2} ^{*4} 1	^{*6} 1	^{*6} 1	^{*10} 1	^{*10} 1	^{*6} 1	^{*6} 1			1
READA	^{*1} ^{*2} BL+ t_{RP}	^{*2} ^{*4} 1	^{*6} 1	^{*6} 1	^{*6} ^{*10} 1	^{*6} ^{*10} 1	^{*6} 1	^{*6} BL+ t_{RP}	^{*2} BL+ t_{RP}	^{*2} ^{*9} BL+ t_{RP}	
WRIT		^{*2} ^{*4} 1	1	1	1	1	^{*6} 1	^{*6} t_{DPL}			1
WRITA	^{*2} ^{*4} BL-1 + t_{DAL}	^{*2} ^{*4} 1	^{*6} 1	^{*6} 1	^{*6} 1	^{*6} 1	^{*6} 1	^{*6} BL-1 + t_{DAL}	^{*2} BL-1 + t_{DAL}	^{*2} BL-1 + t_{DAL}	
PRE	^{*2} ^{*3} t_{RP}	^{*2} ^{*4} 1	^{*7} 1	^{*7} 1	^{*7} 1	^{*7} 1	^{*6} ^{*7} 1	^{*7} 1	^{*2} t_{RP}	^{*2} ^{*8} t_{RP}	1
PALL	^{*3} t_{RP}	t_{RP}					1	1	t_{RP}	t_{RP}	1
REF	t_{RC}	t_{RC}					t_{RC}	t_{RC}	t_{RC}	t_{RC}	t_{RC}
SELFX	t_{RC}	t_{RC}					t_{RC}	t_{RC}	t_{RC}	t_{RC}	t_{RC}

Notes: *1. If $t_{RP}(\min) \leq CL \times t_{CK}$, minimum latency is a sum of $(BL + CL) \times t_{CK}$.

*2. Assume bank of the object is in Idle state.

*3. Assume output is in High-Z state.

*4. $t_{RRD}(\min)$ of other bank (second command will be asserted) is satisfied.

*5. Assume other bank is in active, read or write state.

*6. Assume $t_{RAS}(\min)$ is satisfied.

*7. Assume other banks are not in READA/WRITA state.

*8. Assume after the last data have been appeared on DQ.

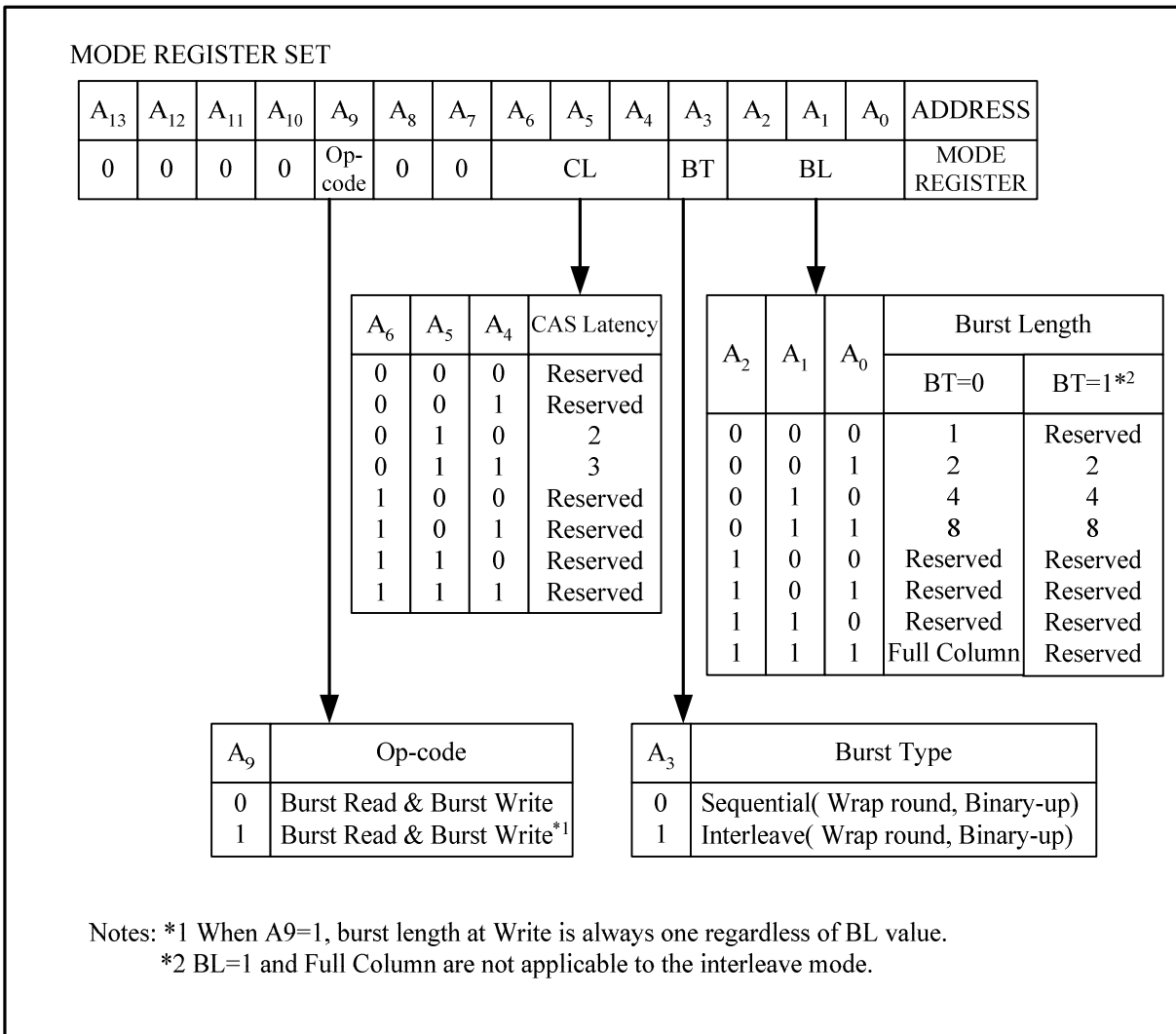
*9. If $t_{RP}(\min) \leq (CL-1) \times t_{CK}$, minimum latency is a sum of $(BL + CL-1) \times t_{CK}$.

*10. Assume no I/O conflict.



Illegal Command

■ MODE REGISTER TABLE



■ ABSOLUTE MAXIMUM RATINGS (See WARNING)

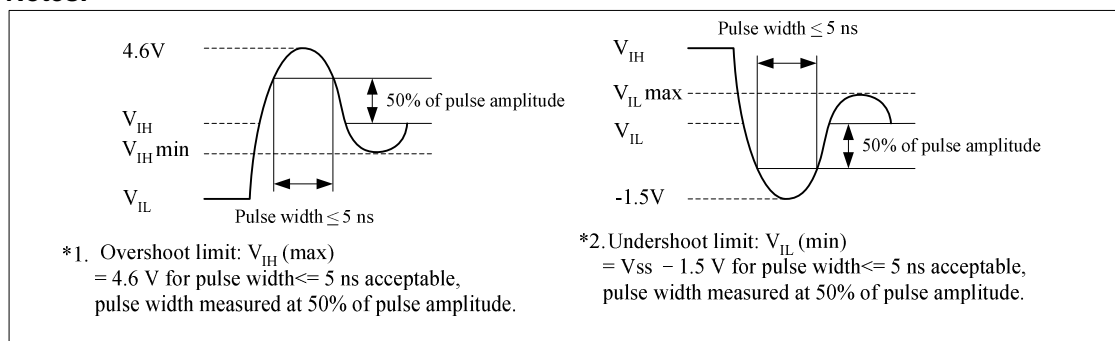
Parameter	Symbol	Value	Unit
Voltage of V _{CC} Supply Relative to V _{SS}	V _{CC} , V _{CCQ}	-0.5 to +4.6	V
Voltage at Any Pin Relative to V _{SS}	V _{IN} , V _{OUT}	-0.5 to +4.6	V
Short Circuit Output Current	I _{OUT}	-50 to +50	mA
Power Dissipation	P _D	1.3	W
Storage Temperature	T _{STG}	-55 to +125	°C

WARNING: Semiconductor devices can be permanently damaged by application of stress (voltage, current, temperature, etc.) in excess of absolute maximum ratings. Do not exceed these ratings.

■ RECOMMENDED OPERATING CONDITIONS (Referenced to V_{SS})

Parameter	Notes	Symbol	Min.	Typ.	Max.	Unit
Supply Voltage		V _{CC} , V _{CCQ}	3.0	3.3	3.6	V
		V _{SS} , V _{SSQ}	0	0	0	V
Input High Voltage	*1	V _{IH}	2.0	—	V _{CC} + 0.5	V
Input Low Voltage	*2	V _{IL}	-0.5	—	0.8	V
Ambient Temperature		T _A	0	—	+65	°C

Notes:



WARNING: The recommended operating conditions are required in order to ensure the normal operation of the semiconductor device. All of the device's electrical characteristics are warranted when the device is operated within these ranges.

Always use semiconductor devices within their recommended operating condition ranges. Operation outside these ranges may adversely affect reliability and could result in device failure.

No warranty is made with respect to uses, operating conditions, or combinations not represented on the data sheet. Users considering application outside the listed conditions are advised to contact their LST representatives beforehand.

■ CAPACITANCE

(T_A = 25°C, f = 1 MHz)

Parameter	Symbol	Min.	Typ.	Max.	Unit
Input Capacitance, Except for CLK	C _{IN1}	2.5	—	5.0	pF
Input Capacitance for CLK	C _{IN2}	2.5	—	4.0	pF
I/O Capacitance	C _{I/O}	4.0	—	6.5	pF

■ DC CHARACTERISTICS

(At recommended operating conditions unless otherwise noted.) Note *1, *2, *3

Parameter		Symbol	Condition	Value		Unit
				Min.	Max.	
Output High Voltage		$V_{OH(DC)}$	$I_{OH} = -2 \text{ mA}$	2.4	—	V
Output Low Voltage		$V_{OL(DC)}$	$I_{OL} = 2 \text{ mA}$	—	0.4	V
Input Leakage Current (Any Input)		I_{LI}	$0 \text{ V} \leq V_{IN} \leq V_{CC}$; All other pins not under test = 0 V	-5	5	μA
Output Leakage Current		I_{LO}	$0 \text{ V} \leq V_{IN} \leq V_{CC}$; Data out disabled	-5	5	μA
Output Leakage Current (Average Power Supply Current)	L43L16064-75	I_{CC1S}	Burst Length = 1 $t_{RC} = \text{min}$ $t_{CK} = \text{min}$ One bank active Output pin open Addresses changed up to one time during t_{CK} (min) $0 \text{ V} \leq V_{IN} \leq V_{IL \text{ max}}$ $V_{IH \text{ min}} \leq V_{IN} \leq V_{CC}$	—	90	mA
	Reference Value*4 @66MHz(CL=2)			—	70	
Precharge Standby Current (Power Supply Current)	L43L16064-75	I_{CC2P}	CKE = V_{IL} All banks idle $t_{CK} = \text{min}$ Power down mode $0 \text{ V} \leq V_{IN} \leq V_{IL \text{ max}}$ $V_{IH \text{ min}} \leq V_{IN} \leq V_{CC}$	—	1	mA
		I_{CC2PS}	CKE = V_{IL} All banks idle CLK = V_{IH} or V_{IL} Power down mode $0 \text{ V} \leq V_{IN} \leq V_{IL \text{ max}}$ $V_{IH \text{ min}} \leq V_{IN} \leq V_{CC}$	—	1	mA
	Reference Value*4 @66MHz(CL=2)	I_{CC2N}	CKE = V_{IH} All banks idle, $t_{CK} = 15 \text{ ns}$ NOP command only, Input signals (except to CMD) are changed one time during 30 ns $0 \text{ V} \leq V_{IN} \leq V_{IL \text{ max}}$ $V_{IH \text{ min}} \leq V_{IN} \leq V_{CC}$	—	15	mA
				—	15	
	I_{CC2NS}	CKE = V_{IH} All banks idle CLK = V_{IH} or V_{IL} Input signal are stable $0 \text{ V} \leq V_{IN} \leq V_{IL \text{ max}}$ $V_{IH \text{ min}} \leq V_{IN} \leq V_{CC}$	—	2	mA	

(Continued)

(Continued)

Parameter	Symbol	Condition	Value		Unit	
			Min.	Max.		
Active Standby Current (Power Supply Current)	L43L16064-75	I_{CC3P}	CKE = V_{IL} Any bank active $t_{CK} = \text{min}$ $0 V \leq V_{IN} \leq V_{IL \text{ max}}$ $V_{IH \text{ min}} \leq V_{IN} \leq V_{CC}$	—	1	mA
		I_{CC3PS}	CKE = V_{IL} Any bank active CLK = V_{IH} or V_{IL} $0 V \leq V_{IN} \leq V_{IL \text{ max}}$ $V_{IH \text{ min}} \leq V_{IN} \leq V_{CC}$	—	1	mA
	Reference Value* ⁴ @66MHz(CL=2)	I_{CC3N}	CKE = V_{IH} Any bank active $t_{CK} = 15 \text{ ns}$ NOP command only, Input signals (except to CMD) are changed one time during 30 ns $0 V \leq V_{IN} \leq V_{IL \text{ max}}$ $V_{IH \text{ min}} \leq V_{IN} \leq V_{CC}$	—	25	mA
				—	25	
	I_{CC3NS}	CKE = V_{IH} Any bank active CLK = V_{IH} or V_{IL} Input signals are stable $0 V \leq V_{IN} \leq V_{IL \text{ max}}$ $V_{IH \text{ min}} \leq V_{IN} \leq V_{CC}$	—	2	mA	
Burst mode Current (Average Power Supply Current)	L43L16064-75	I_{CC4}	$t_{CK} = \text{min}$ Burst Length = 4 Output pin open All-banks active Gapless data $0 V \leq V_{IN} \leq V_{IL \text{ max}}$ $V_{IH \text{ min}} \leq V_{IN} \leq V_{CC}$	—	170	mA
	Reference Value* ⁴ @66MHz(CL=2)			—	85	
Refresh Current #1 (Average Power Supply Current)	L43L16064-75	I_{CC5}	Auto-refresh; $t_{CK} = \text{min}$ $t_{RC} = \text{min}$ $0 V \leq V_{IN} \leq V_{IL \text{ max}}$ $V_{IH \text{ min}} \leq V_{IN} \leq V_{CC}$	—	150	mA
	Reference Value* ⁴ @66MHz(CL=2)			—	100	
Refresh Current #2 (Average Power Supply Current)		I_{CC6}	Self-refresh; $t_{CK} = \text{min}$ CKE $\leq 0.2 V$ $0 V \leq V_{IN} \leq V_{IL \text{ max}}$ $V_{IH \text{ min}} \leq V_{IN} \leq V_{CC}$	—	1	μA

Notes: *1.All voltage are referenced to V_{SS} .

*2.DC characteristics are measured after following the POWER-UP INITIALIZATION procedure.

*3. I_{CC} depends on the output termination or load conditions, clock cycle rate, signal clocking rate.
The specified values are obtained with the output open and no termination register.

*4.This value is for reference only.

■ **AC CHARACTERISTICS**

(At recommended operating conditions unless otherwise noted.) Note *1, *2, *3

Parameter	Notes	Symbol	L43L16064-75		Reference Value*4 @66MHz(CL=2)		Unit
			Min.	Max.	Min.	Max.	
Clock Period	CL = 2	t _{CK2}	10	—	15	—	ns
	CL = 3	t _{CK3}	7.5		10		ns
Clock High Time	*5	t _{CH}	2.5	—	3	—	ns
Clock Low Time	*5	t _{CL}	2.5	—	3	—	ns
Input Setup Time	*5	t _{SI}	2	—	2	—	ns
Input Hold Time	*5	t _{HI}	1	—	1	—	ns
Access Time from Clock (t _{CK} = min)	CL = 2	t _{AC2}	—	6	—	8	ns
	CL = 3	t _{AC3}		6		6	ns
Output in Low-Z	*5	t _{LZ}	0	—	0	—	ns
Output in High-Z	CL = 2	t _{HZ2}	3	6	3	8	ns
	CL = 3	t _{HZ3}	3	6	3	6	ns
Output Hold Time	CL = 2	t _{OH}	3	—	3	—	ns
	CL = 3		3		3		ns
Time between Auto-Refresh command interval	*4	t _{REFI}	—	15.6	—	15.6	μs
Time between Refresh		t _{REF}	—	64	—	64	ms
Transition Time		t _T	0.5	10	0.5	10	ns
CKE Setup Time for Power Down Exit Time	*5	t _{CKSP}	1.5	—	2	—	ns

BASE VALUES FOR CLOCK COUNT/LATENCY

Parameter Notes	Symbol	L43L16064-75			Reference*4 Value @66MHz(CL=2)		Unit	
		Min.		Max.	Min.	Max.		
		CL=3	CL=2					
RAS Cycle Time *9	t _{RC}	67.5	70	—	80	—	ns	
RAS Precharge Time	t _{RP}	22.5	20	—	30	—	ns	
RAS Active Time	t _{RAS}	45	50	110000	50	110000	ns	
RAS to $\overline{\text{CAS}}$ Delay Time	t _{RCD}	22.5	20	—	30	—	ns	
Write Recovery Time	t _{WR}	7.5	10	—	10	—	ns	
RAS to $\overline{\text{CAS}}$ Bank Active Delay Time	t _{RRD}	15	20	—	20	—	ns	
Data-in to Precharge Lead Time	t _{DPL}	15	10	—	10	—	ns	
Data-in to Active/ Refresh Command Period	CL=2	t _{DAL2}	—	1 cyc + t _{RP}	—	1 cyc + t _{RP}	—	ns
	CL=3	t _{DAL3}	2 cyc + t _{RP}	—	—	2 cyc + t _{RP}	—	ns
Mode Resister Set Cycle Time	t _{RSC}	15	20	—	20	—	ns	

CLOCK COUNT FORMULA Note *10

$$\text{Clock} \geq \frac{\text{Base Value}}{\text{Clock Period}} \text{ (Round off a whole number)}$$

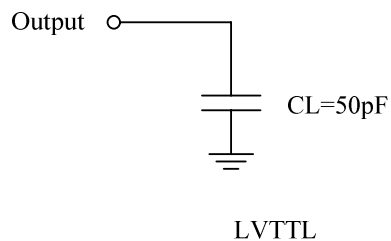
LATENCY - FIXED VALUES

(The latency values on these parameters are fixed regardless of clock period.)

Parameter	Notes	Symbol	L43L16064-75	Reference* ⁴ Value @66MHz(CL=2)	Unit
CKE to Clock Disable		t _{CKE}	1	1	cycle
DQM to Output in High-Z		t _{DQZ}	2	2	cycle
DQM to Input Data Delay		t _{DQD}	0	0	cycle
Last Output to Write Command Delay		t _{OWD}	2	2	cycle
Write Command to Input Data Delay		t _{DWD}	0	0	cycle
Precharge to Output in High-Z Delay	CL = 2	t _{ROH2}	2	2	cycle
	CL = 3	t _{ROH3}	3	3	cycle
Burst Stop Command to Output in High-Z Delay	CL = 2	t _{BSh2}	2	2	cycle
	CL = 3	t _{BSh3}	3	3	cycle
$\overline{\text{CAS}}$ to $\overline{\text{CAS}}$ Delay (min)		t _{CCD}	1	1	cycle
$\overline{\text{CAS}}$ Bank Delay (min)		t _{CBd}	1	1	cycle

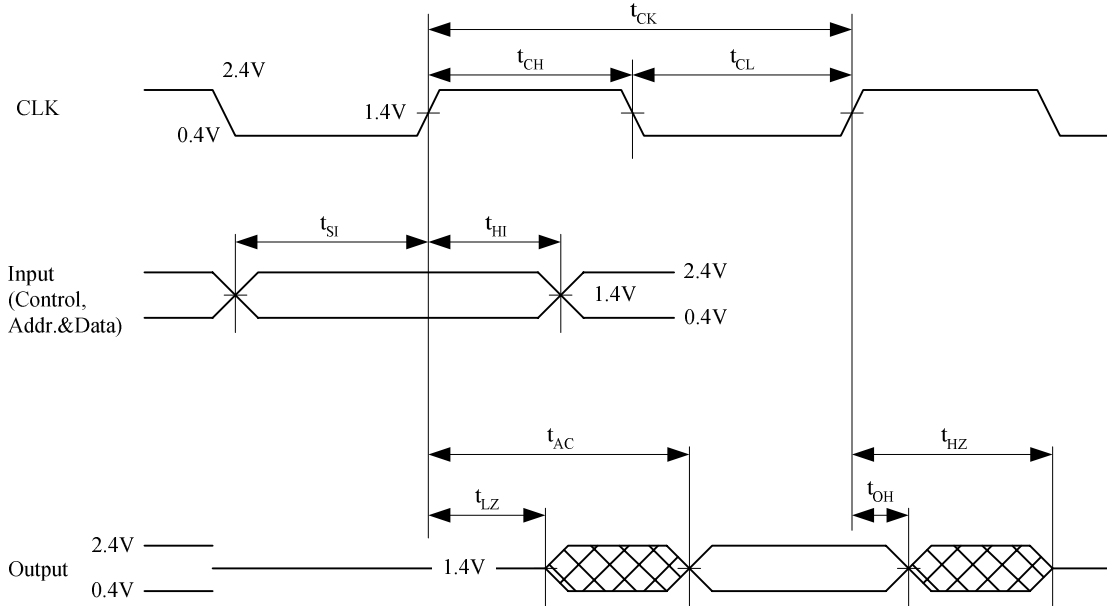
- Notes:**
- *1. AC characteristics are measured after following the POWER-UP INITIALIZATION procedure.
 - *2. AC characteristics assume $t_T = 1$ ns and 50 pF of capacitive load.
 - *3. 1.4 V is the reference level for measuring timing of input signals. Transition times are measured between V_{IH} (min) and V_{IL} (max). (See Fig. 5)
 - *4. This value is for reference only.
 - *5. If input signal transition time (t_T) is longer than 1 ns; $[(t_T/2) - 0.5]$ ns should be added to t_{AC} (max), t_{HZ} (max), and t_{CKSP} (min) spec values, $[(t_T/2) - 0.5]$ ns should be subtracted from t_{LZ} (min), t_{HZ} (min), and t_{OH} (min) spec values, and $(t_T - 1.0)$ ns should be added to t_{CH} (min), t_{CL} (min), t_{SI} (min), and t_{HI} (min) spec values.
 - *6. t_{AC} also specifies the access time at burst mode.
 - *7. t_{AC} and t_{OH} are the specs value under AC test load circuit shown in Fig. 4.
 - *8. Specified where output buffer is no longer driven.
 - *9. Actual clock count of t_{RC} (t_{RC}) will be sum of clock count of t_{RAS} (t_{RAS}) and t_{RP} (t_{RP}).
 - *10. All base values are measured from the clock edge at the command input to the clock edge for the next command input. All clock counts are calculated by a simple formula: clock count equals base value divided by clock period (round off to a whole number).

Fig. 4 - OUTPUT LOAD CIRCUIT



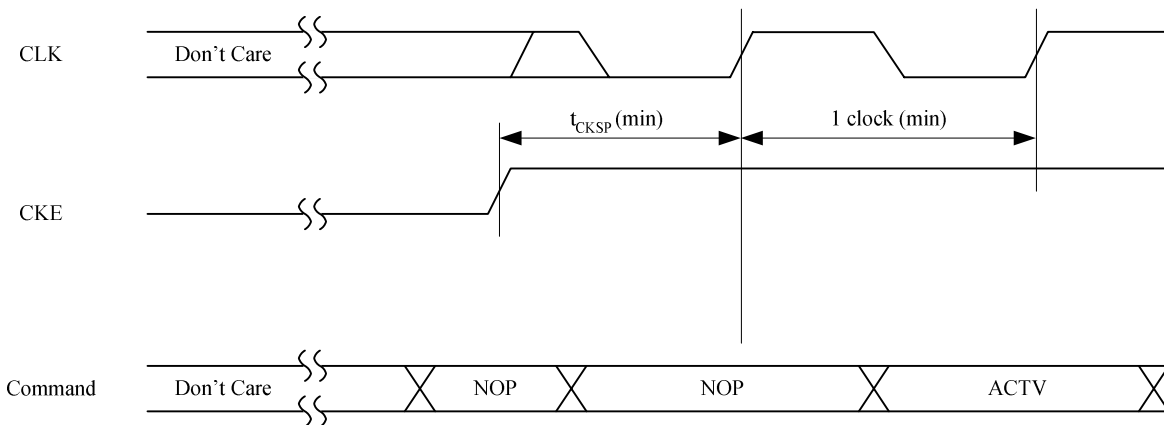
Note: By adding appropriate correlation factors to the test condition, t_{AC} and t_{OH} measured when the output is coupled to the Output Load Circuit are within specifications.

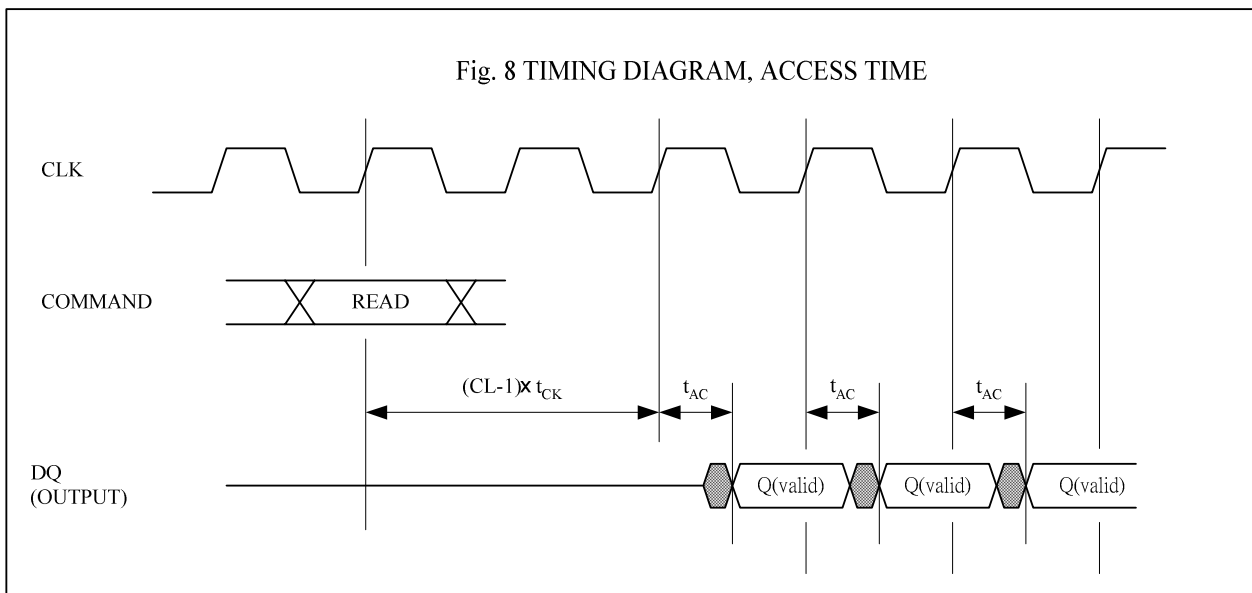
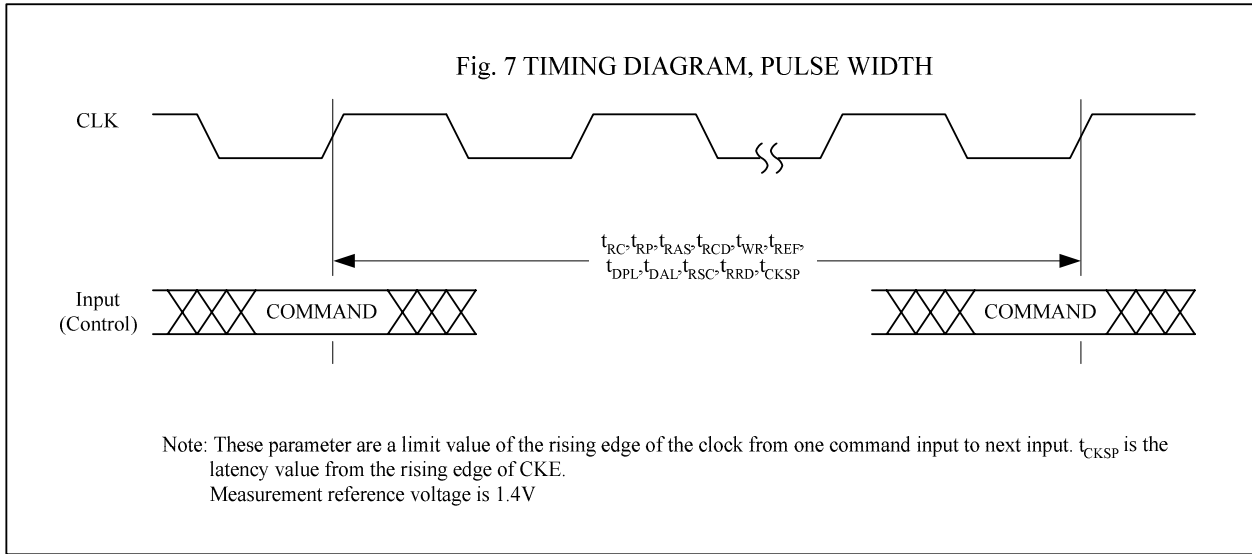
Fig. 5 TIMING DIAGRAM, SETUP, HOLD AND DELAY TIME



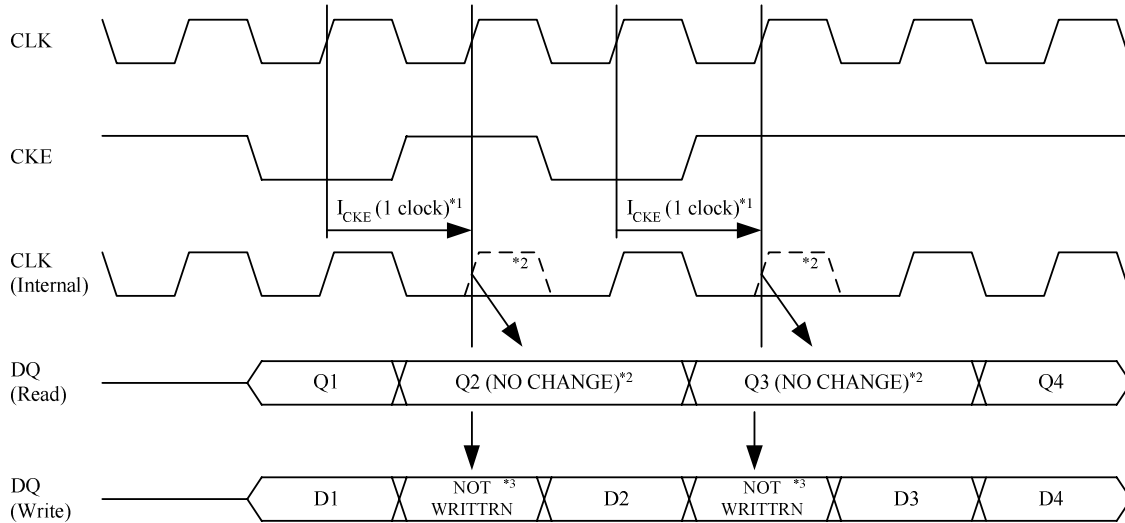
Note: Reference level of input signal is 1.4V for LVTTL.
 Access time is measured at 1.4V for LVTTL.

Fig. 6 TIMING DIAGRAM, DELAY TIME FOR POWER DOWN EXIT



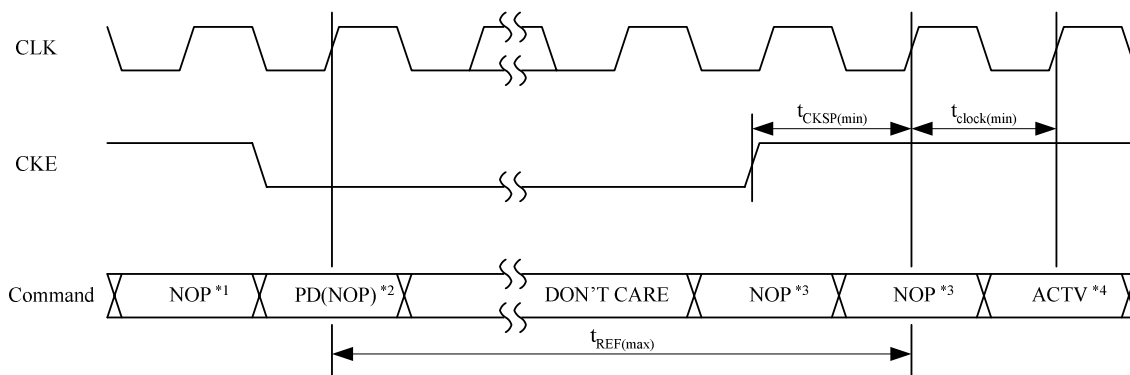


TIMING DIAGRAM -1 : CLOCK ENABLE - READ AND WRITE SUSPEND (@ BL= 4)

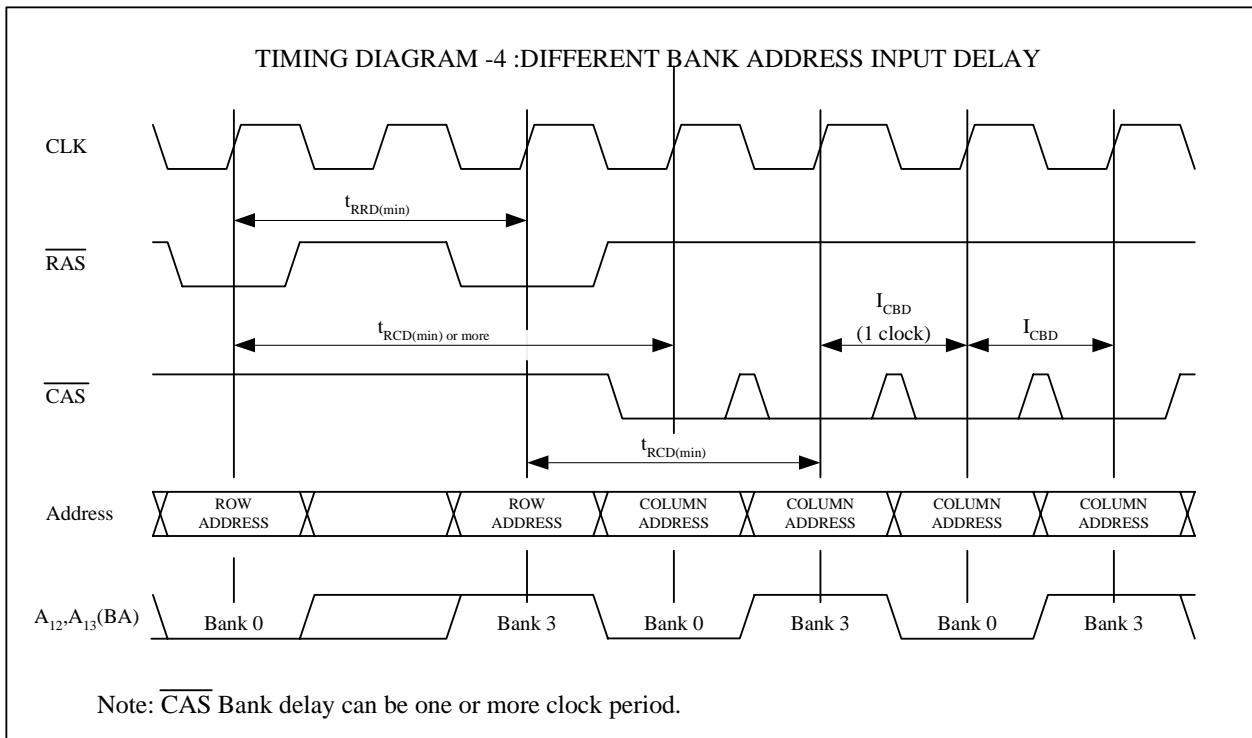
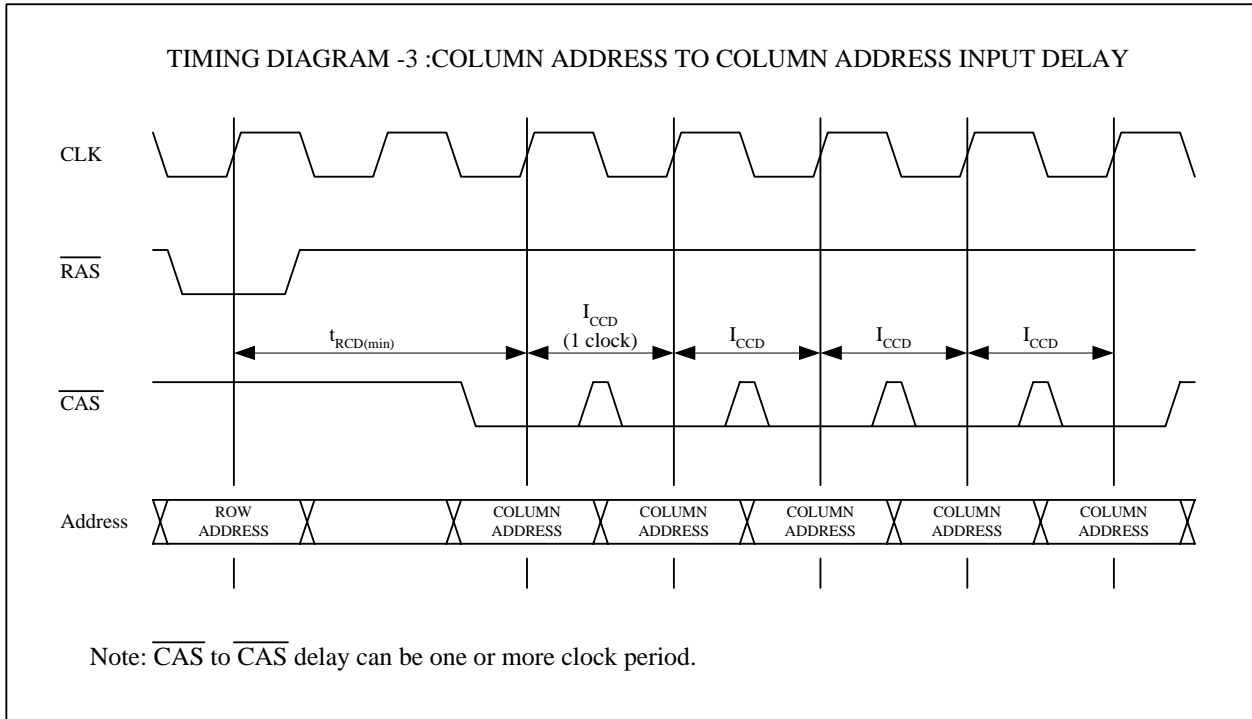


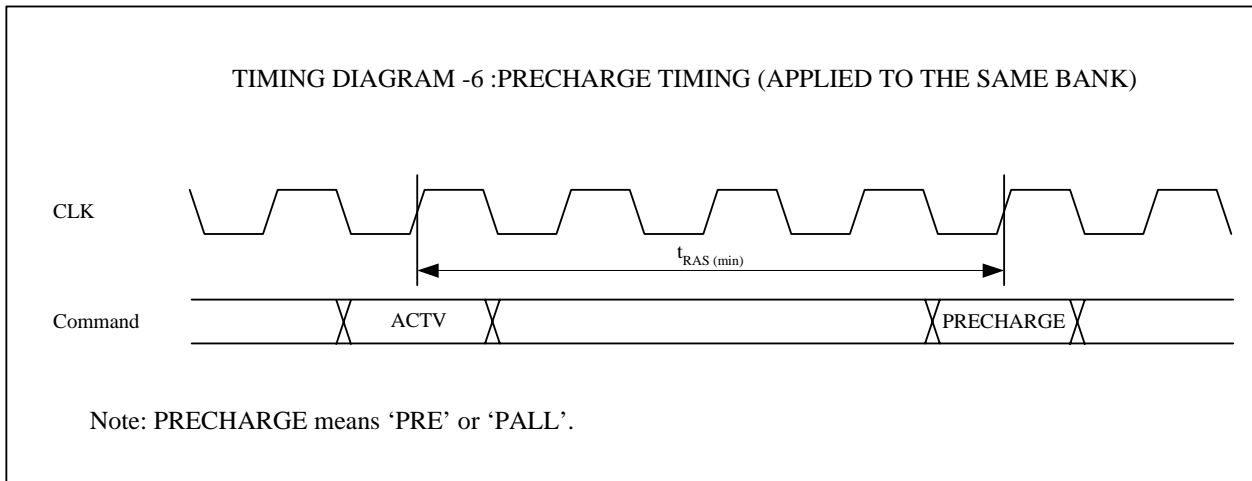
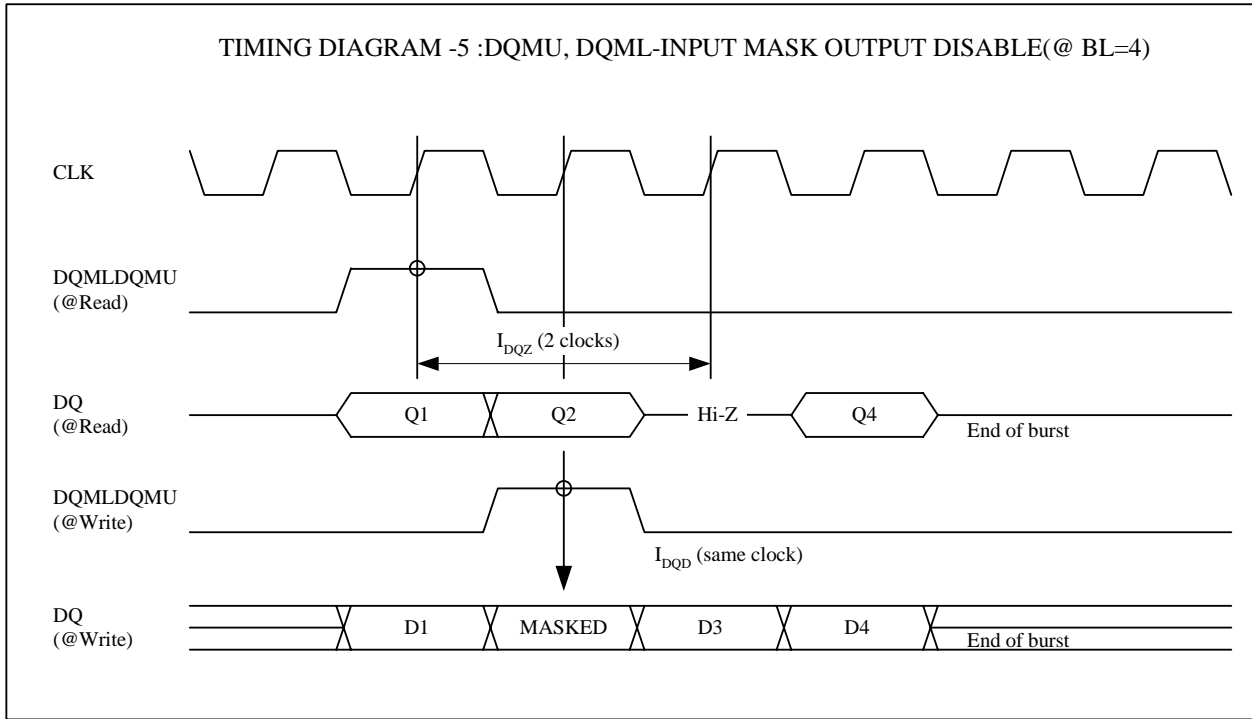
- Notes:
- *1. The latency of CKE (I_{CKE}) is one clock.
 - *2. During read mode, burst counter will not be incremented/ decremented at the next clock of CSUS command. Output data remain the same data.
 - *3. During write mode, data at the next clock of CSUS command is ignored.

TIMING DIAGRAM -2 : CLOCK ENABLE - POWER DOWN ENTRY AND EXIT

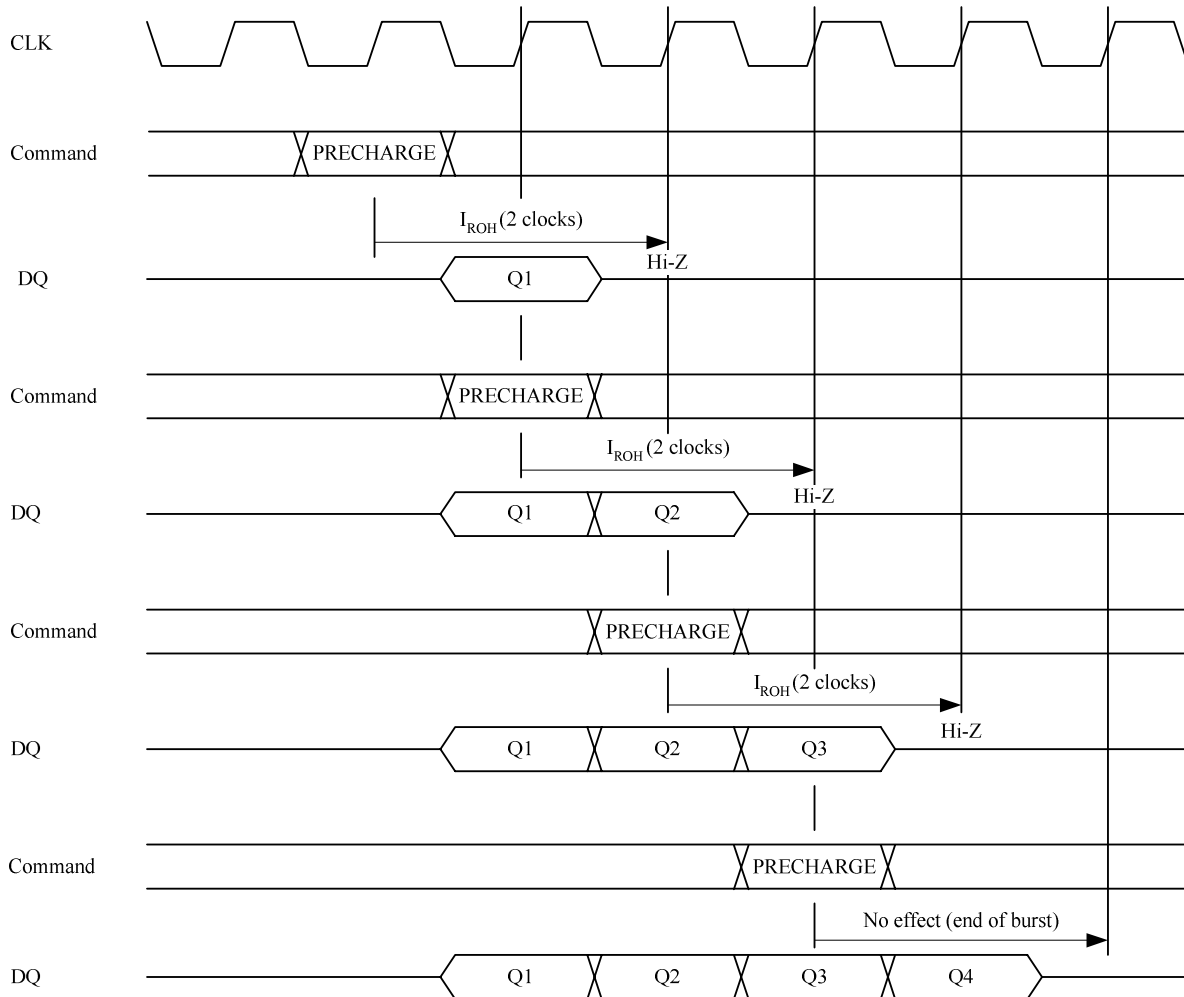


- Notes:
- *1. Precharge command (PER or PALL) should be asserted if any bank is active and in the burst mode.
 - *2. Precharge command can be posted in conjunction with CKE after the last read data have been appeared on DQ.
 - *3. It is recommended to apply NOP command in conjunction with CKE.
 - *4. The ACTV command can be latched $t_{CKSP}(\text{min}) + 1$ clock (min).

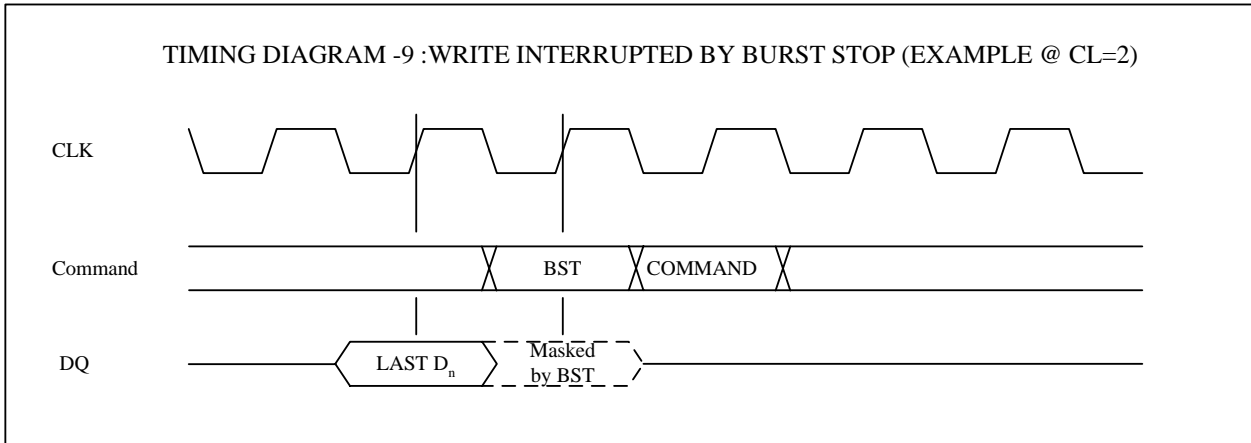
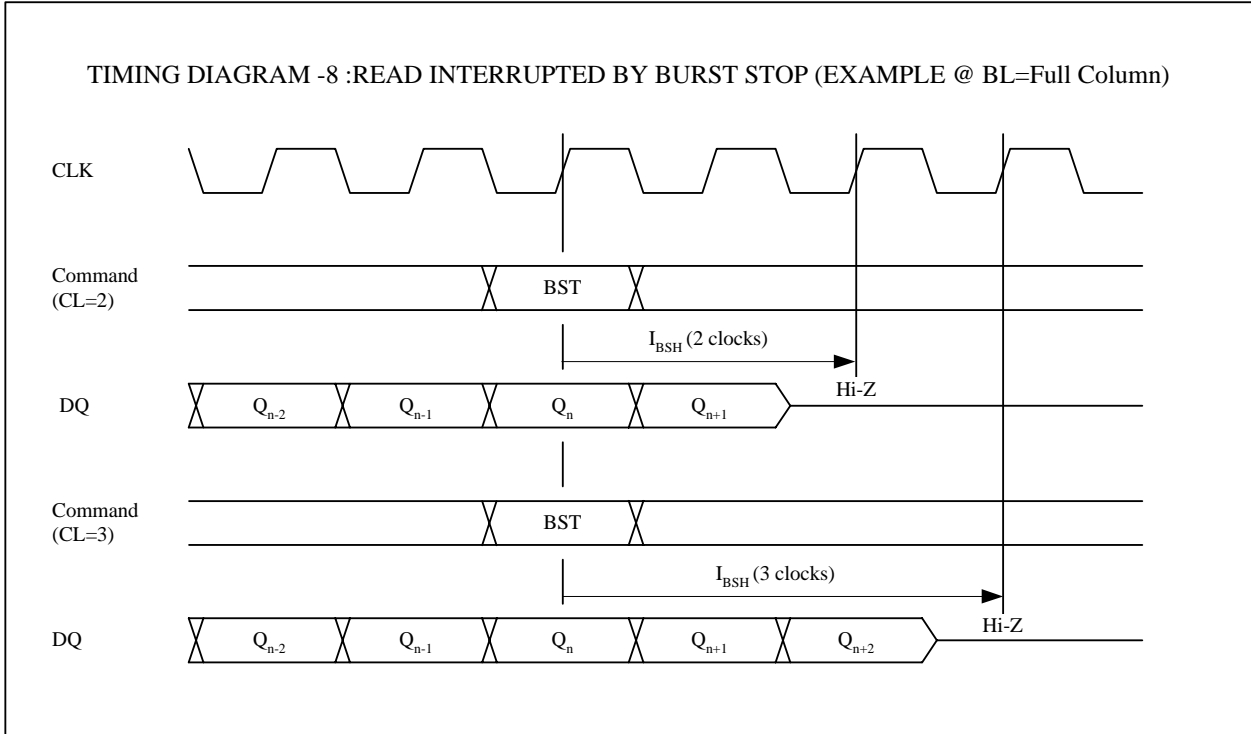


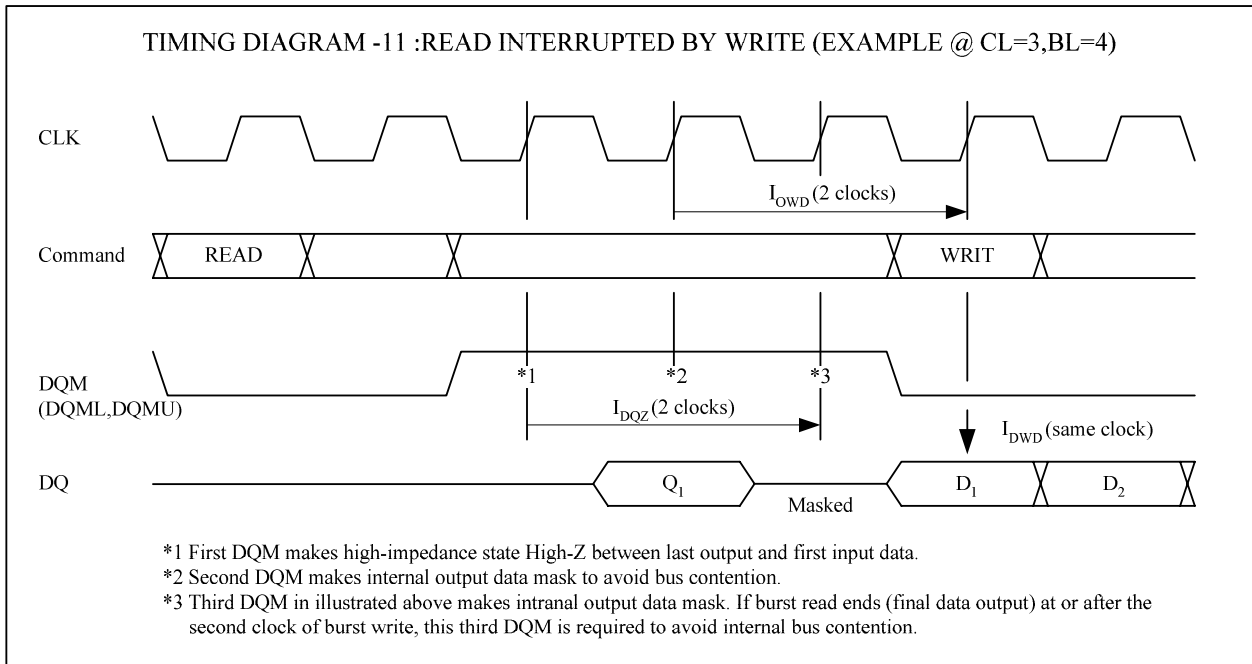
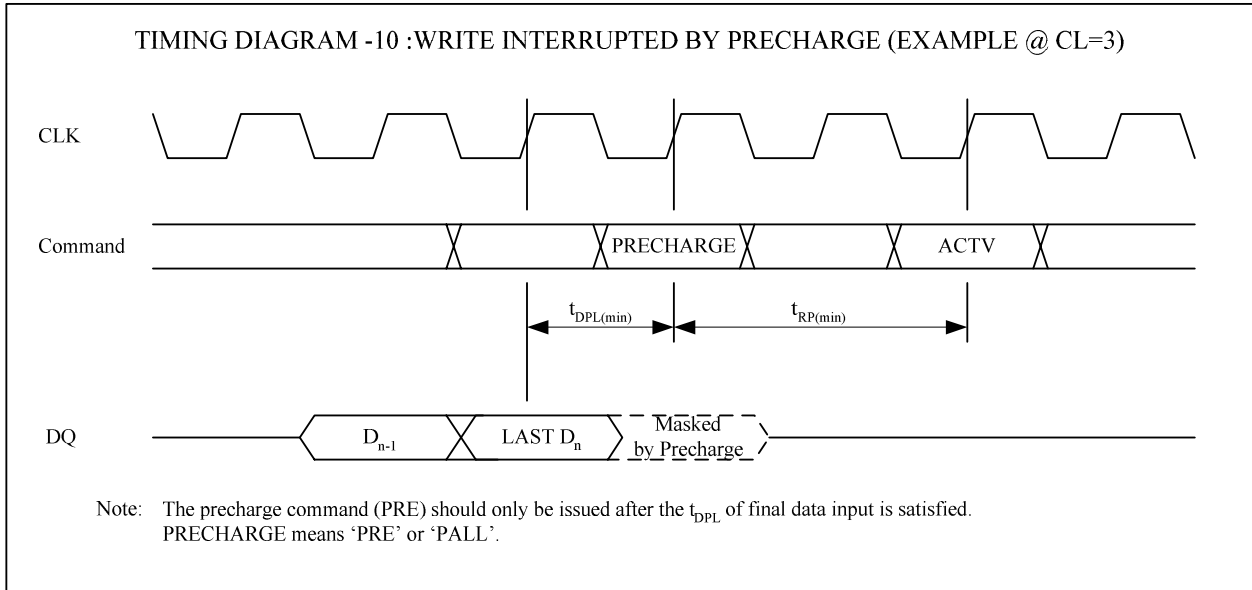


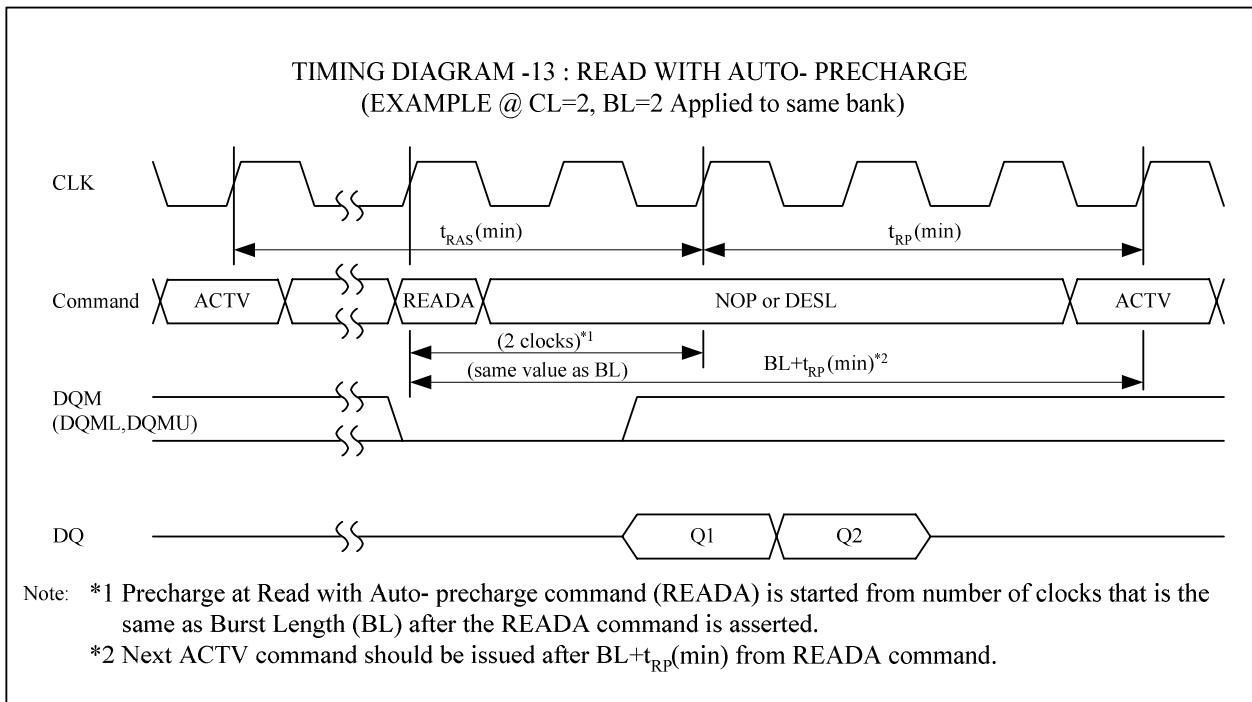
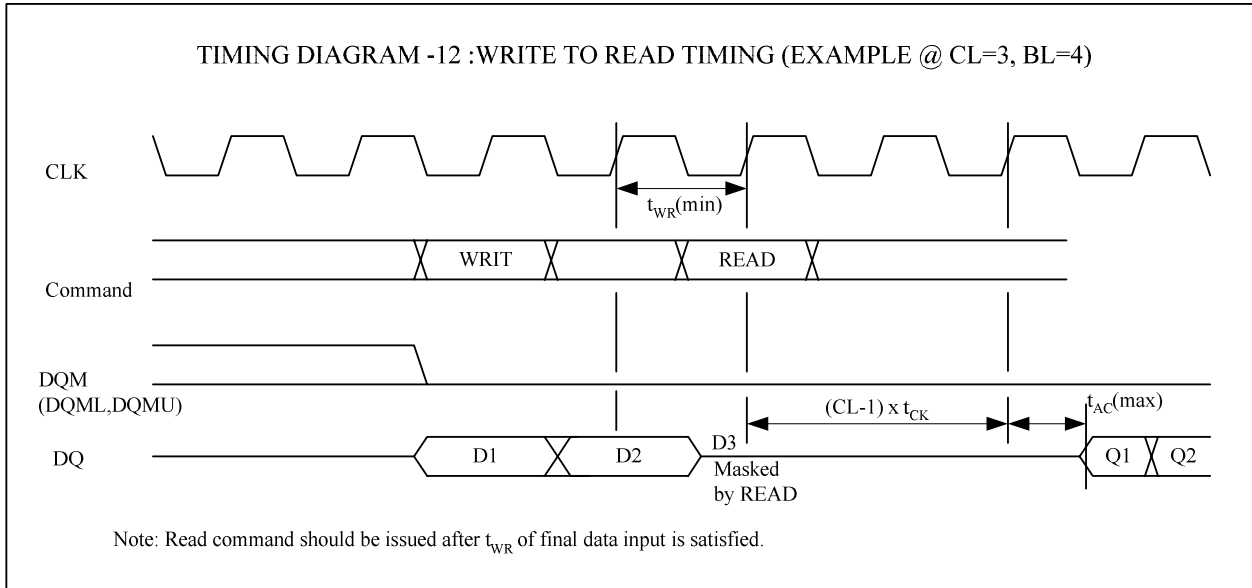
TIMING DIAGRAM -7 :READ INTERRUPTED BY PRECHARGE (EXAMPLE @CL=2,@ BL=4)

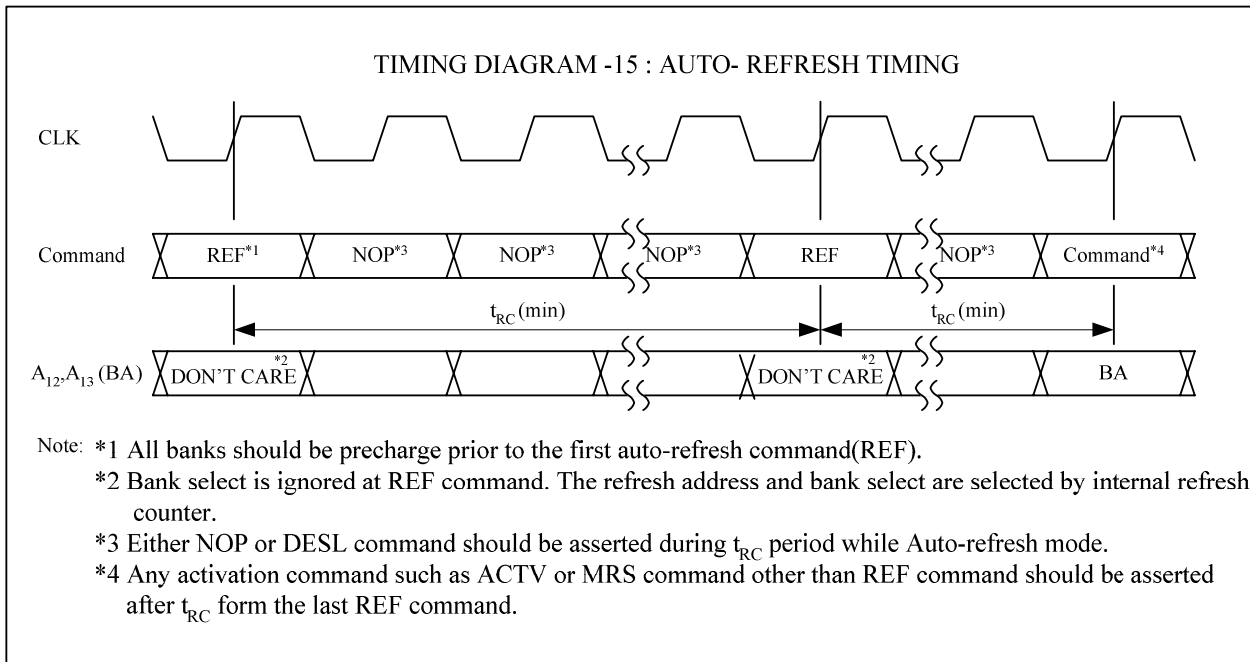
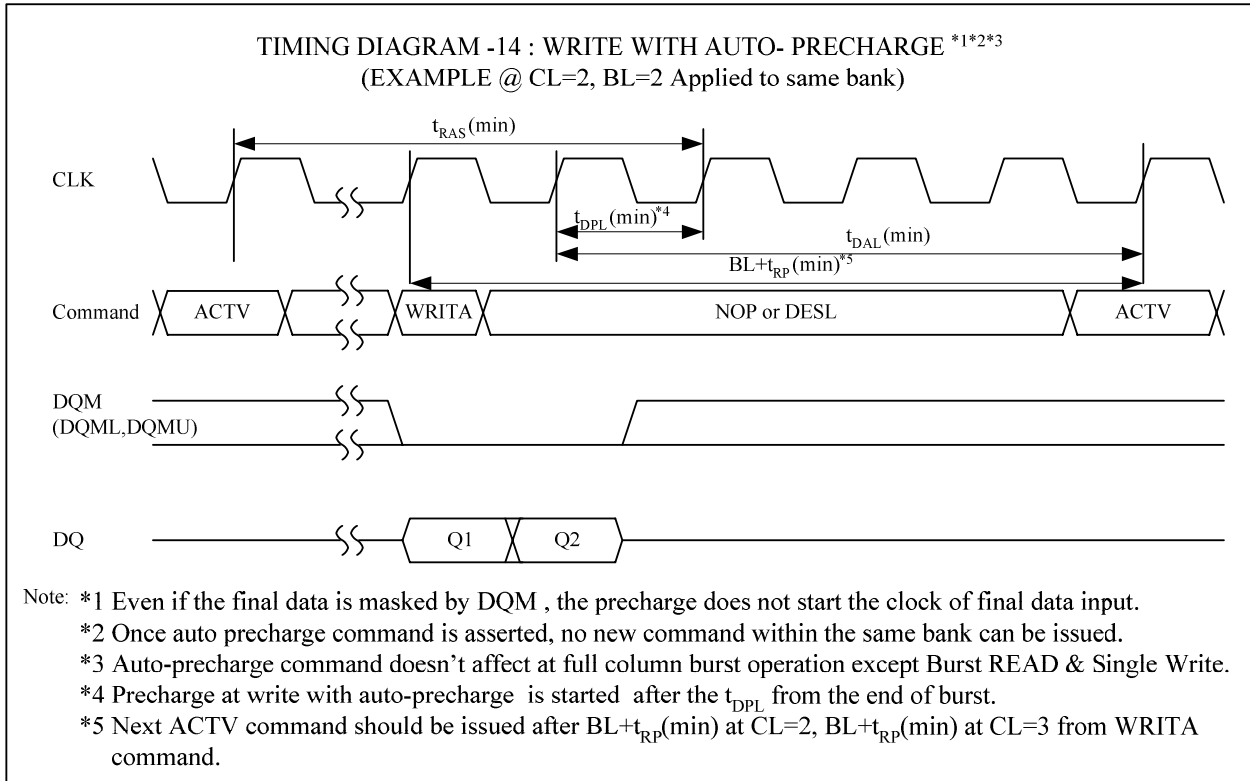


Note: In case of CL=2, the I_{ROH} is 2 clocks.
 In case of CL=3, the I_{ROH} is 3 clocks.
 PRECHARGE means 'PRE' or 'PALL'.

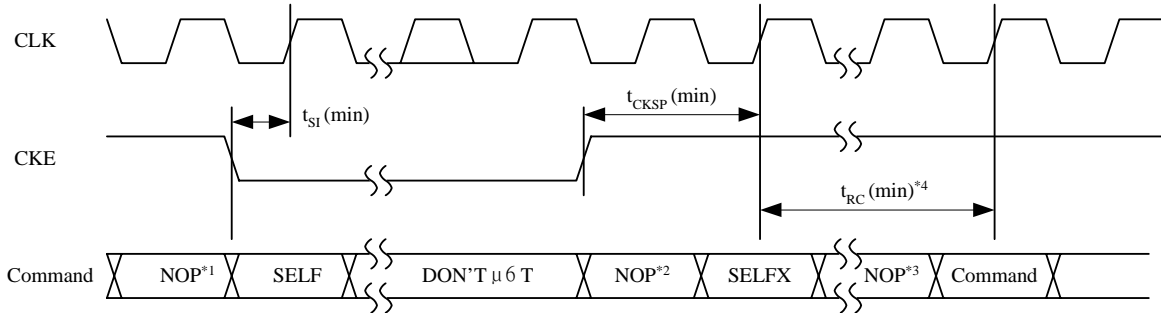






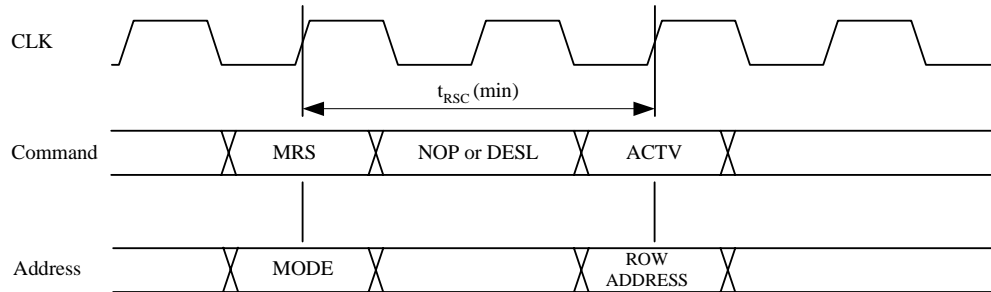


TIMING DIAGRAM -16 : SELF- REFRESH ENTRY AND EXIT TIMING



- Note: *1 precharge command (PRE or PALL) should be asserted if any bank is active prior to self-refresh Entry command (SELF).
 *2 The self-refresh exit command (SELFX) is latched after t_{CKSP} (min) . It is recommended to apply NOP command in conjunction with CKE.
 *3 Either NOP or DESL command can be used during t_{RC} period.
 *4 CKE should be held high within one t_{RC} period t_{CKSP} .

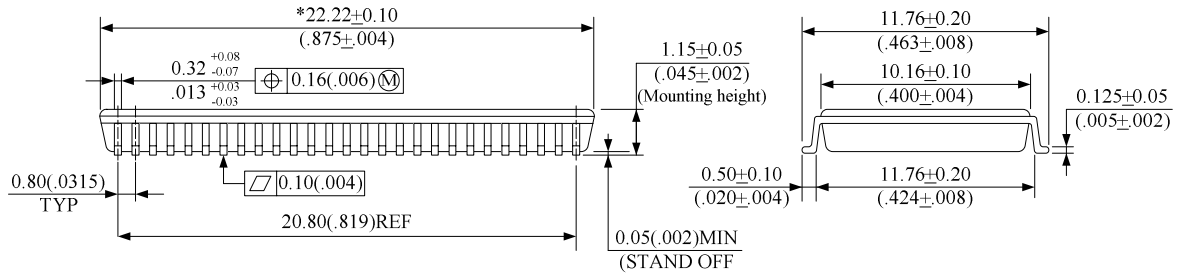
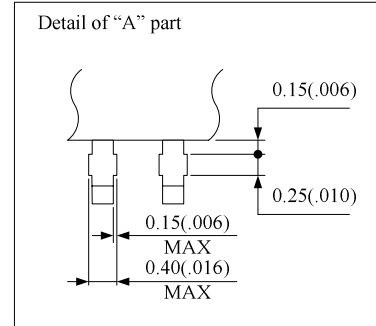
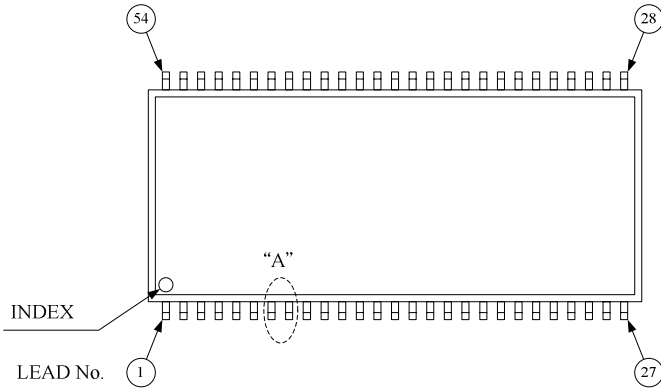
TIMING DIAGRAM -17 : MODE REGISTER SET TIMING



Note: The mode register Set command (MRS) should only be asserted after all bank have been precharged.

Package Dimension

*: Resin protrusion. (Each side: 0.15 (.006) MAX)



Part Number

